

# Beam Instrumentation

## CAS Chavannes Feb.2017

H.Schmickler, CERN



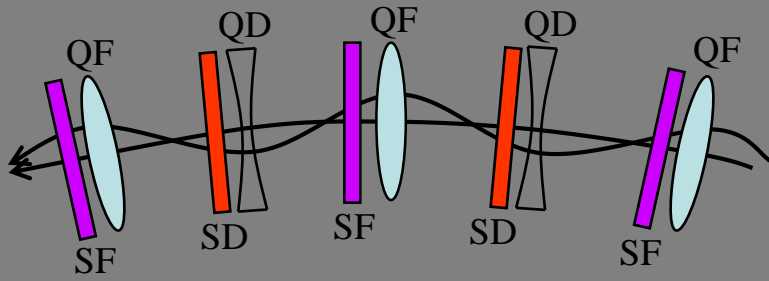
# Introduction

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- **What do we mean by beam instrumentation?**
  - The “eyes” of the machine operators
    - i.e. the instruments that observe beam behaviour
    - “An accelerator can never be better than the instruments measuring its performance!”
- **What does work in beam instrumentation entail?**
  - Design, construction & operation of instruments to observe particle beams
  - R&D to find new or improve existing techniques to fulfill new requirements
  - A combination of the following disciplines
    - Applied & Accelerator Physics; Mechanical, Electronic & Software Engineering
- **What beam parameters do we measure?**
  - Beam Position
    - Horizontal and vertical throughout the accelerator
  - Beam Intensity (& lifetime measurement for a storage ring/collider)
    - Bunch-by-bunch charge and total circulating current
  - Beam Loss
    - Especially important for high brightness and superconducting machines
  - Beam profiles
    - Transverse and longitudinal distribution

# More Measurements

- Machine Tune

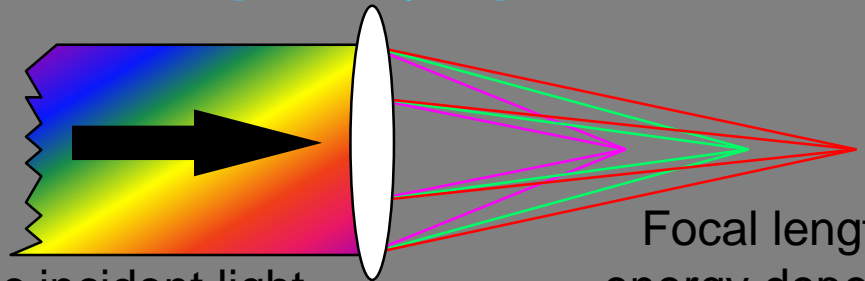


Characteristic Frequency of the Magnetic Lattice Given by the strength of the Quadrupole magnets

- Machine Chromaticity

Optics Analogy:

Lens [Quadrupole]



Achromatic incident light [Spread in particle energy]

Focal length is energy dependent

Spread in the Machine Tune due to Particle Energy Spread Controlled by Sextupole magnets



# Not further treated:

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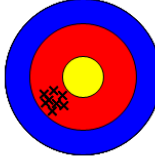

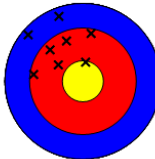
- **Luminosity Measurements**  
(dedicated arrangements close to the IP)
- **Direct Emittance Measurements**  
(simultaneous measurement of size and divergence)
- **Particle identification, Time of flight...**  
(relevant for secondary beam lines)
- **Synchronization,**  
**beam arrival time monitors**  
...this needs a full course on its own

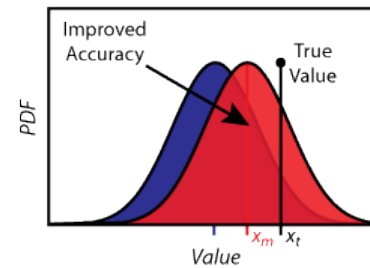
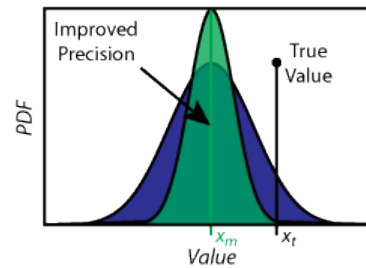
## ....in general...

- In every instrument we
  - intercept information of the particle beam
  - convert it to an electrical signal
  - digitize it and transmit it to the control room
  - display it, use it for the computation of corrections, use it in real-time feedback loops...
  - store it for further analysis
- What can we intercept?
  - the beam particles themselves  
(typical: beam screen, beam loss monitors...)
  - the electromagnetic field of the beam  
(most instruments, important: beam position monitors)
  - light emitted by the beam  
(typical: transverse and longitudinal profiles)

# Accuracy, Precision, Resolution

- Very often confused in day-to-day language
- Accuracy:= also called trueness of measurement
- Precision:= how well can I reproduce my measurements
- Resolution:= smallest possible difference in successive measurements

	Accurate	Inaccurate (systematic error)
Precise		
Imprecise (reproducibility error)		



Ex: BPM: Mechanical and electrical offsets, gain factors influence the accuracy, various noise sources or timing jitter influence the precision, ADC resolution can limit the resolution.



# The Typical Instruments

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- **Beam Position**
  - electrostatic or electromagnetic pick-ups and related electronics
- **Beam Intensity**
  - beam current transformers
- **Beam Profile**
  - secondary emission grids and screens
  - wire scanners
  - synchrotron light monitors
  - ionization and luminescence monitors
  - femtosecond diagnostics for ultra short bunches
- **Beam Loss**
  - ionization chambers or pin diodes
- **Machine Tune and Chromaticity (derived quantities)**



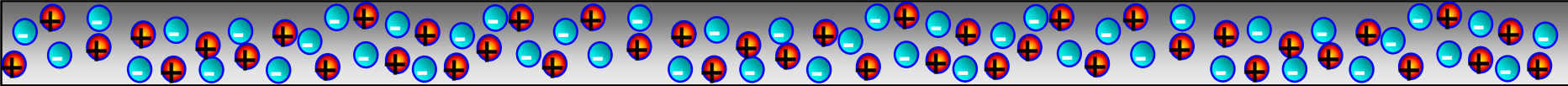
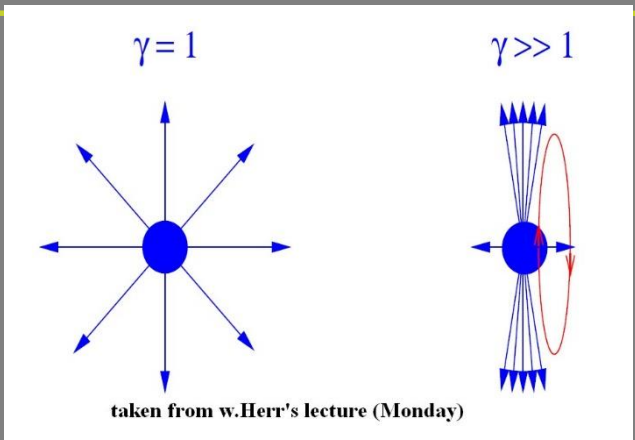
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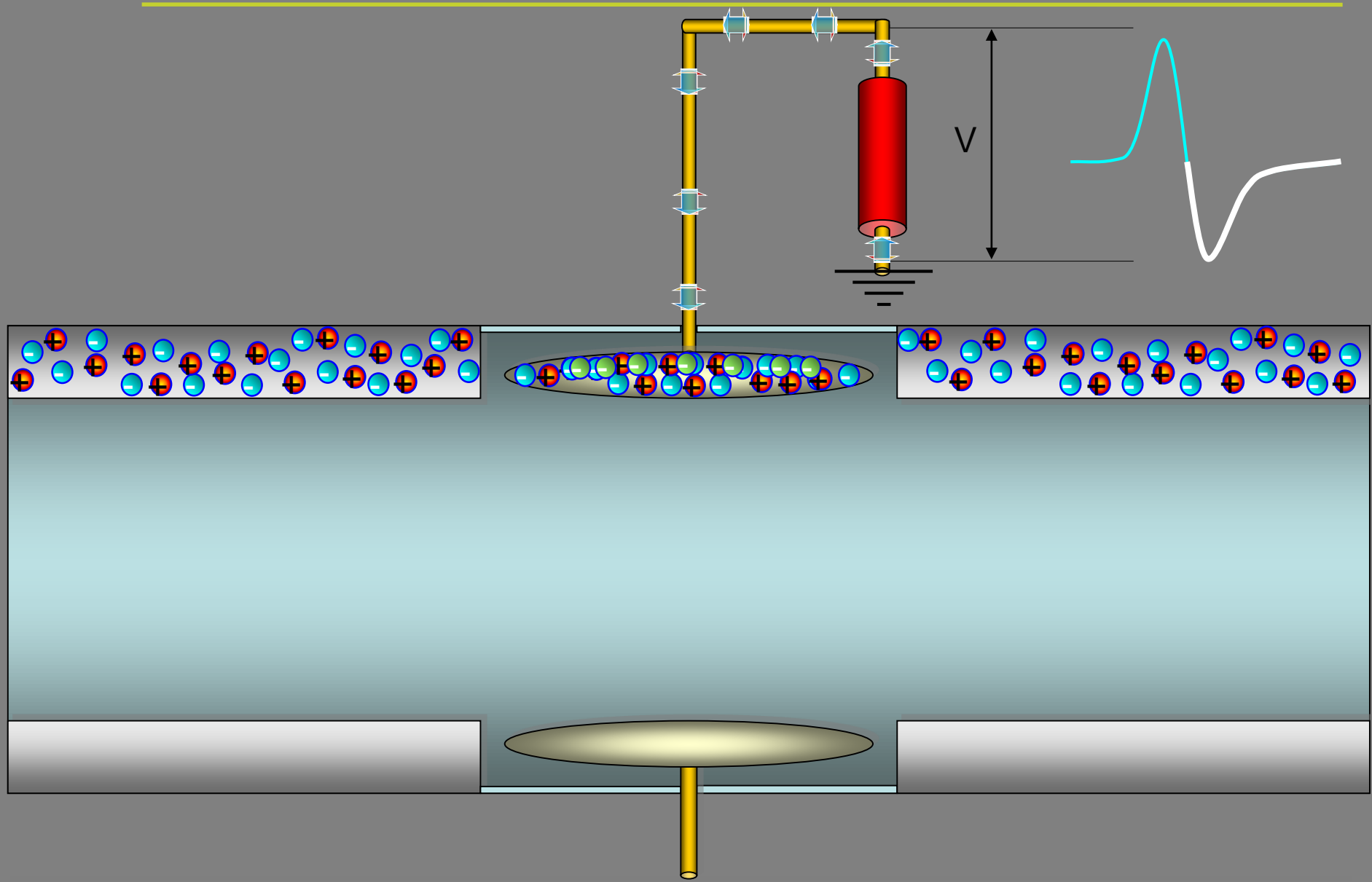


# Beam Image (wall) current– The Principle



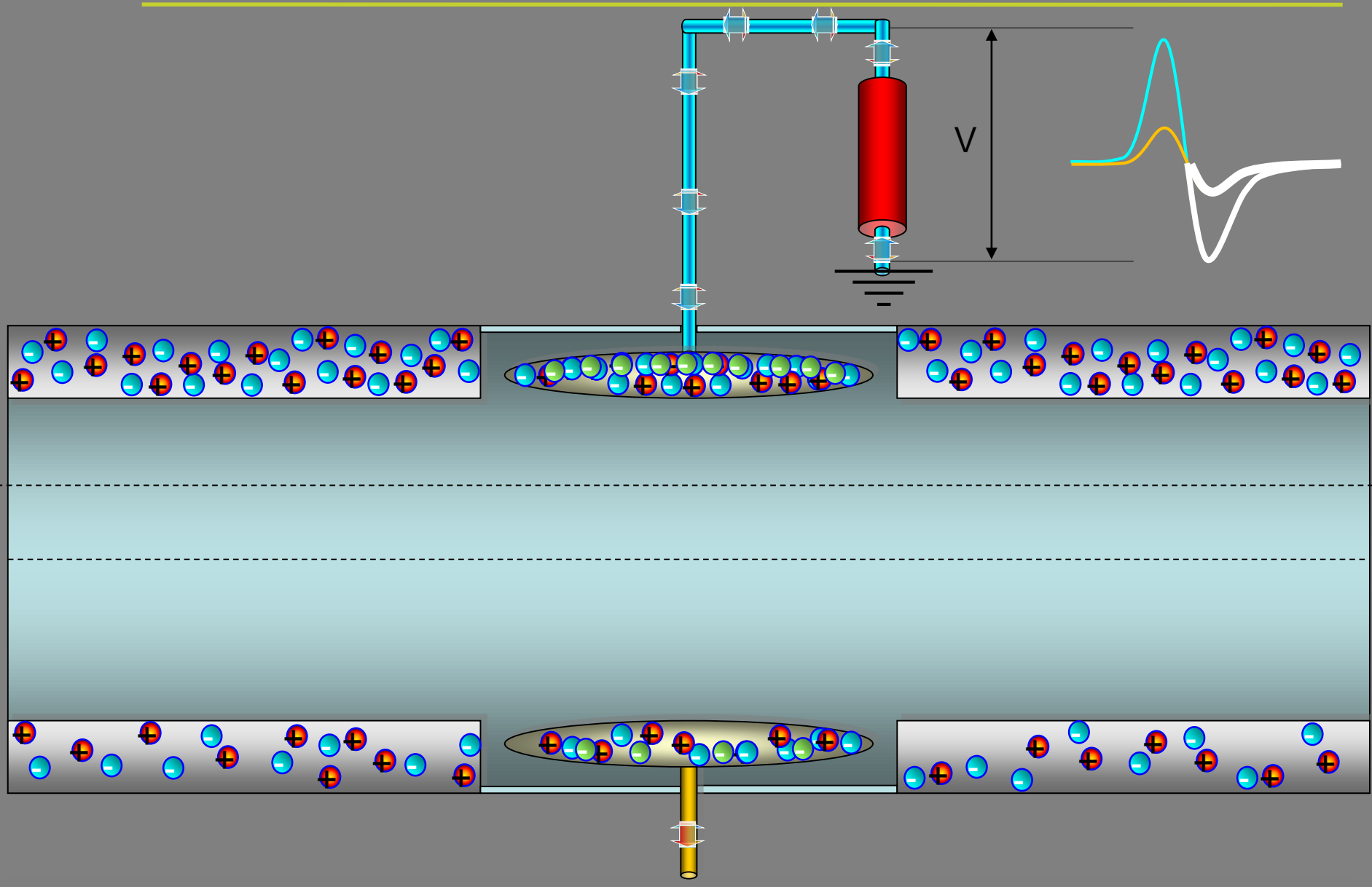


# Electrostatic Monitor – The Principle





# Electrostatic Beam Position Monitor

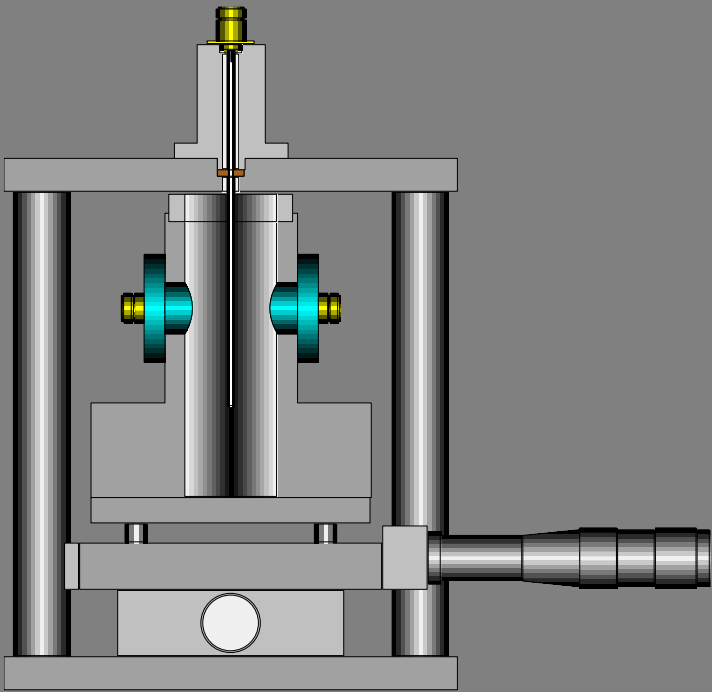


# Principle of Beam Position Monitors

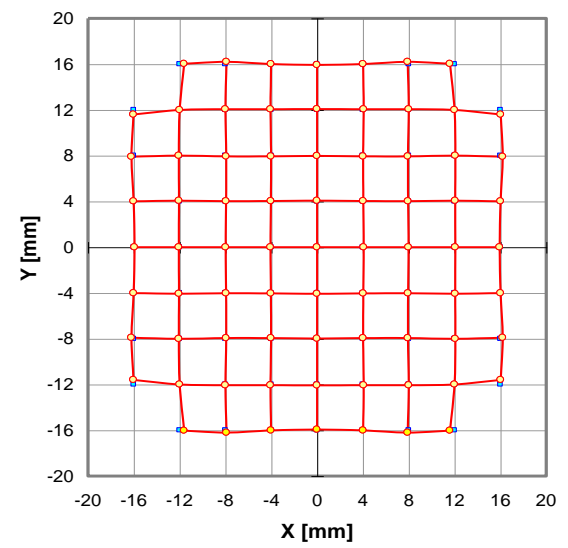
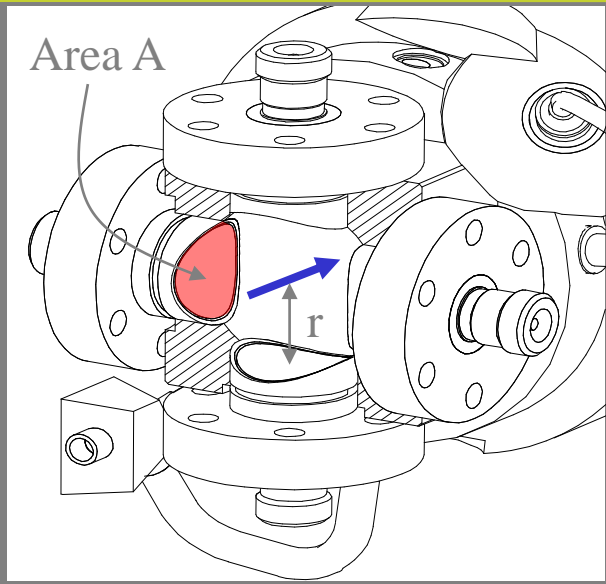
- Intercept “beam image current” in the vacuum chamber on two isolated (capacitive) pickups.
- Other pickups (more involved): shoebox (linear) pickups, stripline directional couplers....
- Use high precision Rf electronics to shape the signals (short bunches deliver signals with high frequency content)
  - amplifiers
  - filters
  - down converters
- Digitize the individual pickup signals
- Eliminate the intensity information from the pickup signals (= “normalization”)
- Compute the position from the pickup-signal difference
- Linearize the pickup response
- Calibrate the system in metric units

# Electrostatic Pick-up – Button

- ✓ Low cost  $\Rightarrow$  most popular
- ✗ Non-linear
  - requires correction algorithm when beam is off-centre



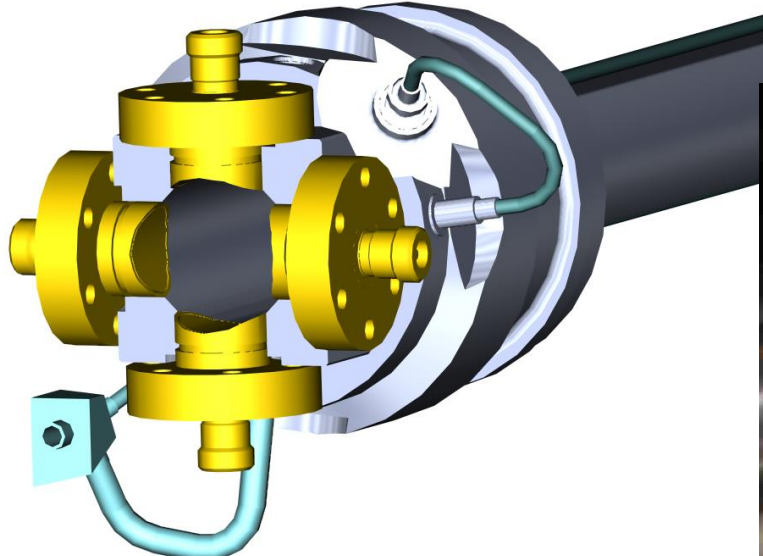
Position mapping with movable antenna



$$X = 2.30 \cdot 10^{-5} X_1^5 + 3.70 \cdot 10^{-5} X_1^3 + 1.035 X_1 + 7.53 \cdot 10^{-6} X_1^3 Y_1^2 + 1.53 \cdot 10^{-5} X_1 Y_1^4$$

# Realization of Button BPM at LHC

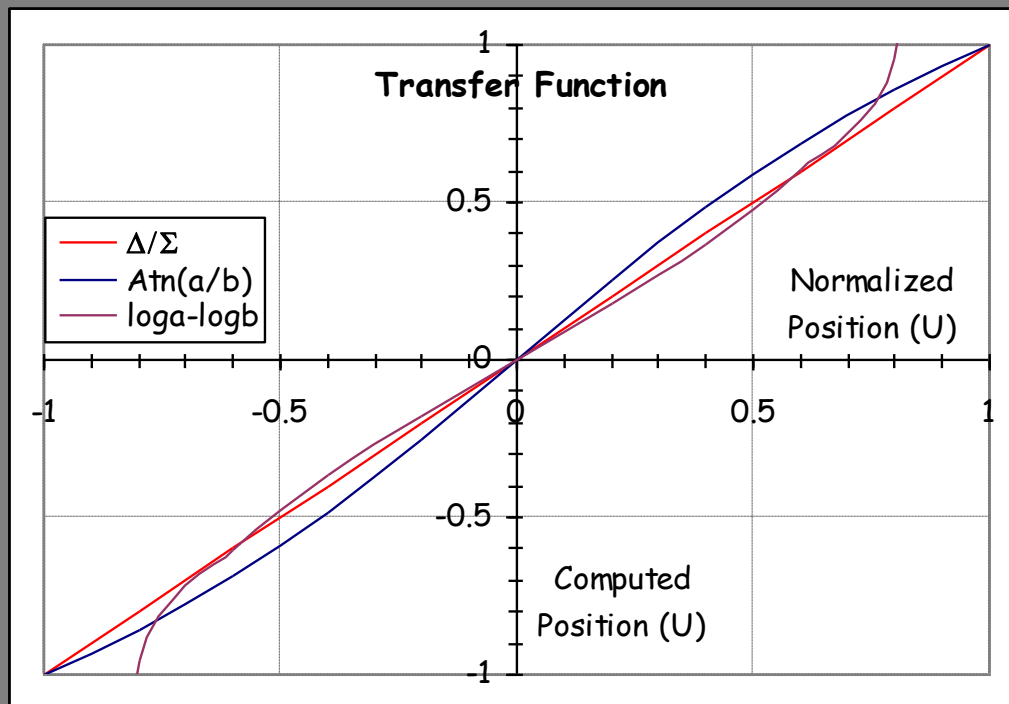
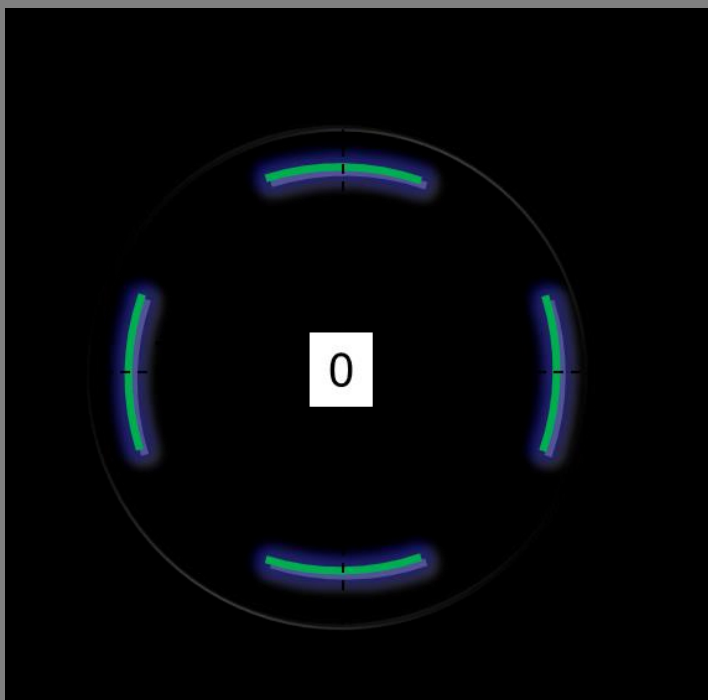
Example LHC:  $\varnothing$  24 mm, half aperture  $a=25$  mm, installed inside cryostat  
Critically:  $50 \Omega$  matching of button to standard feed-through.



From C. Boccard, C. Palau-Montava et al.(CERN).

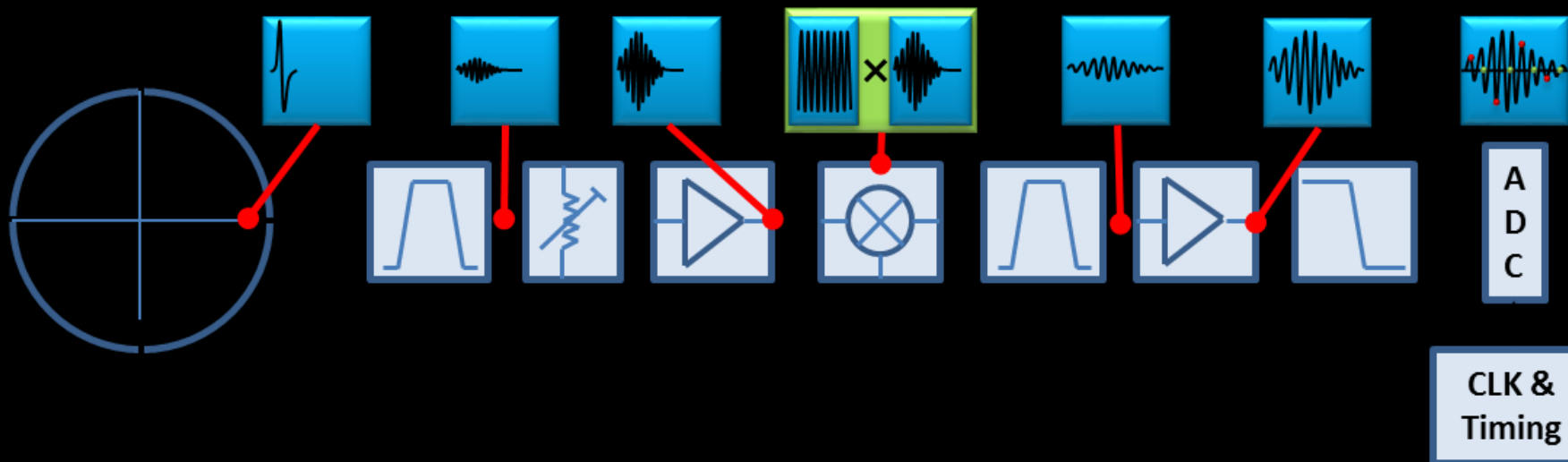
# Normalising the Position Reading

- To make it independent of intensity
- 3 main methods:
  - Difference/Sum :  $(V_A - V_B) / (V_A + V_B) = \Delta / \Sigma$
  - Phase :  $\text{Arctan}(V_A / V_B)$
  - Logarithm :  $\text{Log}(V_A) - \text{Log}(V_B)$



# Modern BPM Read-out Electronics

- Based on the individual treatment of the electrode signals
  - Use of frequency domain signal processing techniques
    - Developed for telecommunications market
  - Rely on high frequency & high resolution analogue to digital converters
    - Minimising analogue circuitry
    - Frequency down-conversion used if necessary to adapt to ADC sampling rate
    - All further processing carried out in the subsequent digital electronics







# Orbit Acquisition

Thu Oct 18 13:20:30 2001

Start Tasks Operation SPS Top10 EDUMP Reset P2 Reset Active Tasks Exit

SPS\_orbit

QUIT	SPS XORBIT V9.01/2K+1	Done	Info
Acquire	Reference Orbit	Reference Catalog	Send Correction
MON & COD	no reference set no date		Cancel Correction
Acquisition Time	Load Orbit	Difference	Sum
Closed Orbit	dp/p-offset shown	Control Plane Hor Vert	Skeleton
Settings & Specials	Reject at 3.0 sigma	MICADO	MD Specials Other Tools

Loading correct TWISS file...  
Reading Twiss ft\_inj\_v2001...  
Initializing Twiss for 724 elements  
724 elements copied to Twiss

CLOSED ORBIT : 18/10/2001 13:19:12  
SC = 946 PROTON [# 59855]  
MOMENTUM - 14.00 GeV  
TWISS - ft\_inj\_v2001  
GAIN/TIME = 0 / 1000 ms  
AVERAGE = 1  
DP/P - 0.16 permill

Data stored in /usr/opt/orbit/hpslx

SPS\_Selection  
File Supercycle Help  
Running SC 946  
Proton 1  
Proton 1  
0 - 9420ms (9420ms)  
Ready.

Xdataviewer

QUIT CERN/GL Xdataviewer 0.4 ZOOMIN:Pick first point Kick

Views Subview External Editor Load/Save Help

Plot Grid OFF Zeroline OFF OP ONE Zoom In

Monitor Plot  
CO TIME = 1000 ms QH = 26.62 QV = 26.58 Energy = 14.00  
0.0  
GLOBAL: mean - 0.386 RMS - 0.936 #pu - 112  
Monitor horizontal

Da 63.0000 0.41000 dy 6.66746 BPH.41209  
Cu 63.3173 7.07746 monx

CO TIME = 1000 ms QH = 26.62 QV = 26.58 Energy = 14.00  
0.0  
GLOBAL: mean = -0.006 RMS = 0.520 #pu = 113

Horizontal

Vertical

This orbit excursion is too large!



# Orbit Correction (Operator Panel)

Thu Oct 18 13:24:30 2001

Start Tasks Operation SPS Top10 EDUMP Reset P2 Reset Active Tasks

Exit

**SPS\_orbit**

QUIT SPS XORBIT V9.01/2K+1 Done Info

Acquire Reference Orbit Reference Catalog Send Correction

MON & COD no reference set no date Cancel Correction

Acquisition Time Load Orbit Difference Sum Skelcton

Closed Orbit dp/p-offset shown Control Plane Hor Vert MD Specials

Settings & Specials Reject at 3.0 sigma MICADO Other Tools

4	MDV.42707	0.0069
	MDV.22307	0.0188
	MDVA.21932	0.0158
	MDVA.21703	0.0040
-----		
5	MDV.42707	0.0071
	MDV.22307	0.0205
	MDVA.21932	0.0169
	MDVA.21703	0.0052
	MDV.42507	-0.0035
Number of iterations required (max # iterations = 5		

**SPS\_Selection**

File Supercycle Help

Running SC 946  
Proton 1

Proton 1  
0 - 9420ms (9420ms)

Ready.

**Xdataviewer**

QUIT CERN/SL Xdataviewer 6.4 ZOOMIN:Pick first point Kick Clean Reverse

Views Subview External Editor Load/Save Help Select

Plot Grid OFF Zerolinc OFF OP ONE Zoom In Box

**Predicted Correction Results** 18/10/01 13:23:45

0.0 Before Correction 112.0

GLOBAL: mean = -0.006 RMS = 0.520 #pu = 113

Da 56.0000 0.2700 dy -1.3117 BPV.33509 Cu 55.9502 -1.0417 mon

0.0 Difference 112.0

GLOBAL: mean = 0.023 RMS = 0.328 #pu = 113

Da 26.0000 0.40381 dy 5.63786 BPV.21509 Cu 25.5858 6.04167 diff

0.0 After Correction 112.0

GLOBAL: mean = 0.017 RMS = 0.403 #pu = 113

Da 4.00000 0.73520 dy -0.7352 BPV.10909 Cu 3.88267 0.00000 res



# Orbit Correction (Detail)



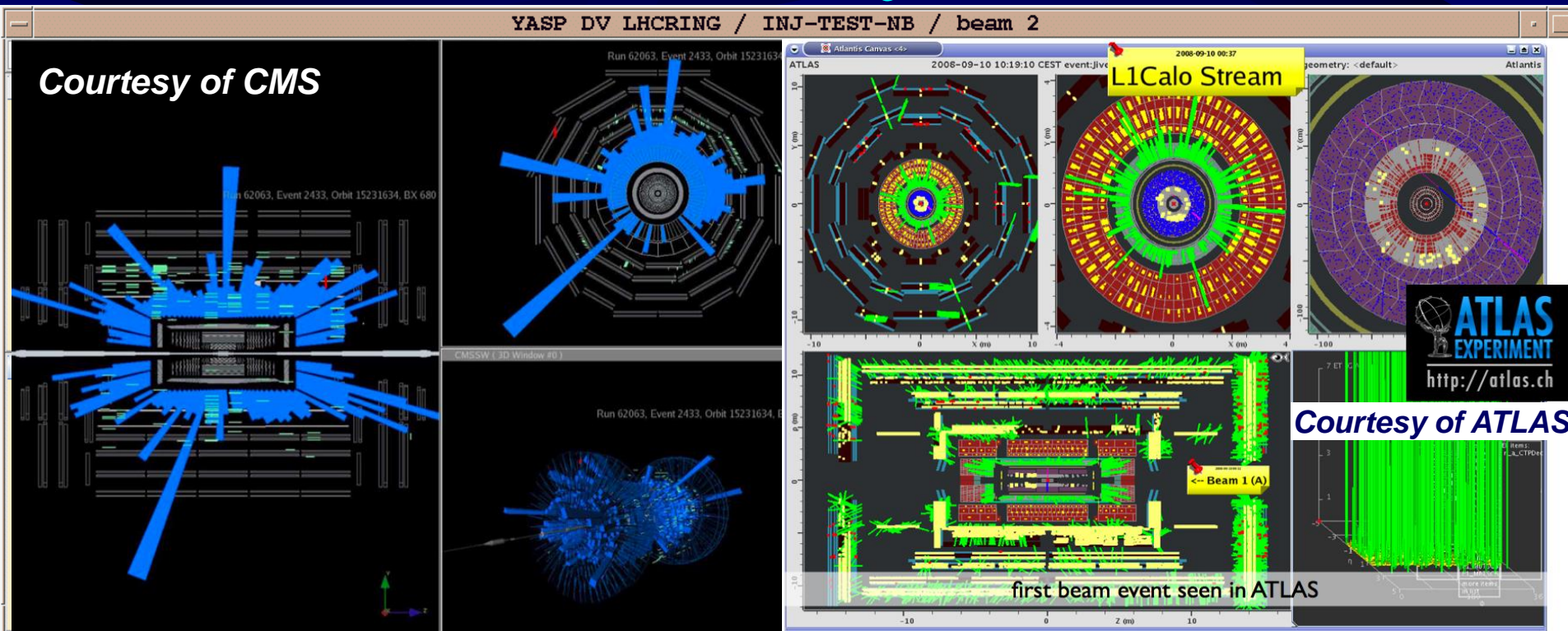


# Beam Threading

- Threading the beam round the LHC ring (very first commissioning)
  - One beam at a time, one hour per beam.
  - Collimators were used to intercept the beam (1 bunch,  $2 \times 10^9$  protons)
  - Beam through 1 sector (1/8 ring)
    - correct trajectory, open collimator and move on.

## Beam 2 threading

*BPM availability ~ 99%*





Kind of boring: orbit corrections....but:

Beam physics data derived from BPM rawdata:

Examples:

orbit difference for different beam momenta → dispersion

Orbit difference for different beam intensities →

Transverse impedance of vacuum chamber

Turn by turn trajectory on each BPM; beam forced on constant oscillation →

Beta function and phase advances



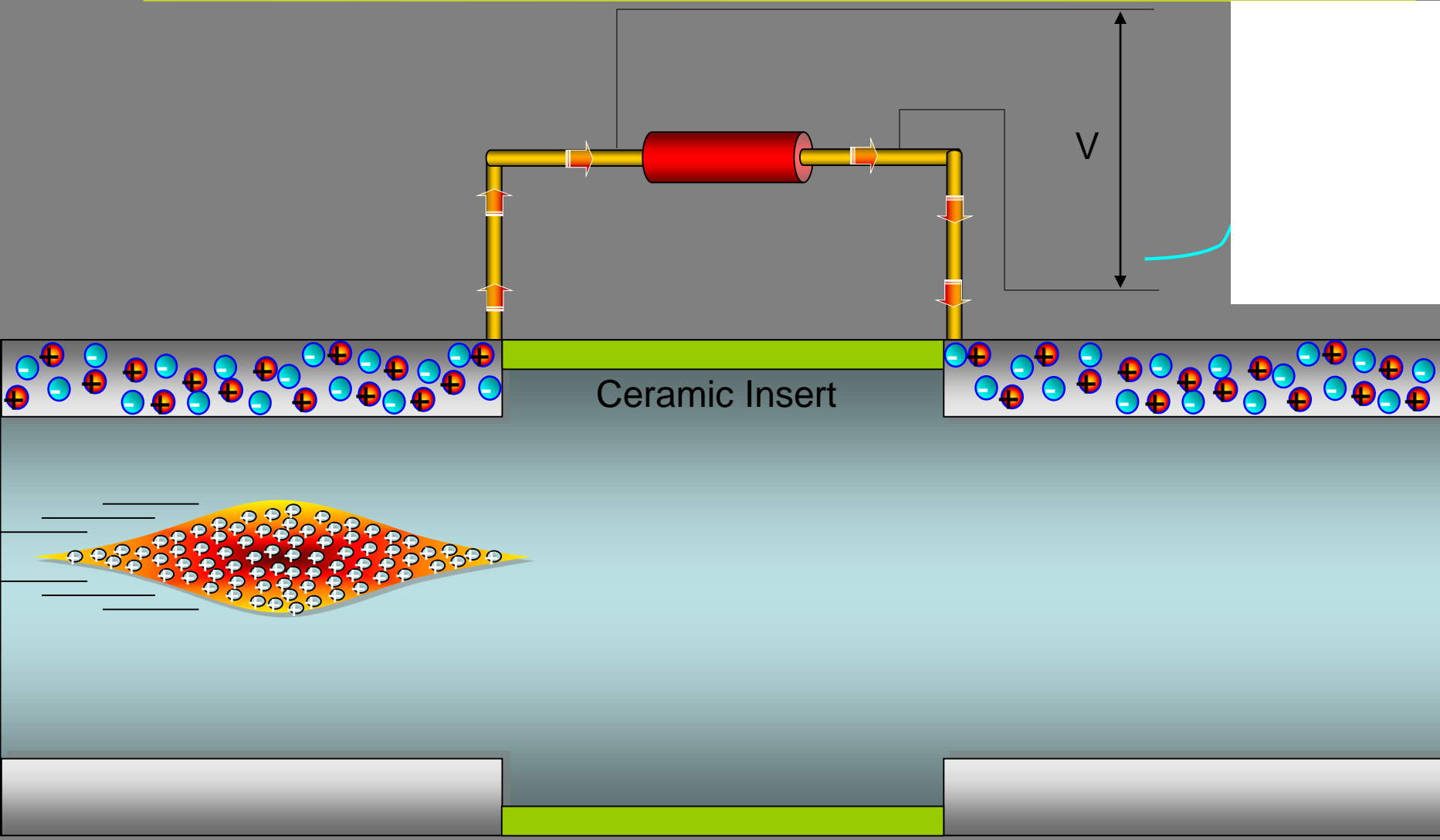
# The Typical Instruments

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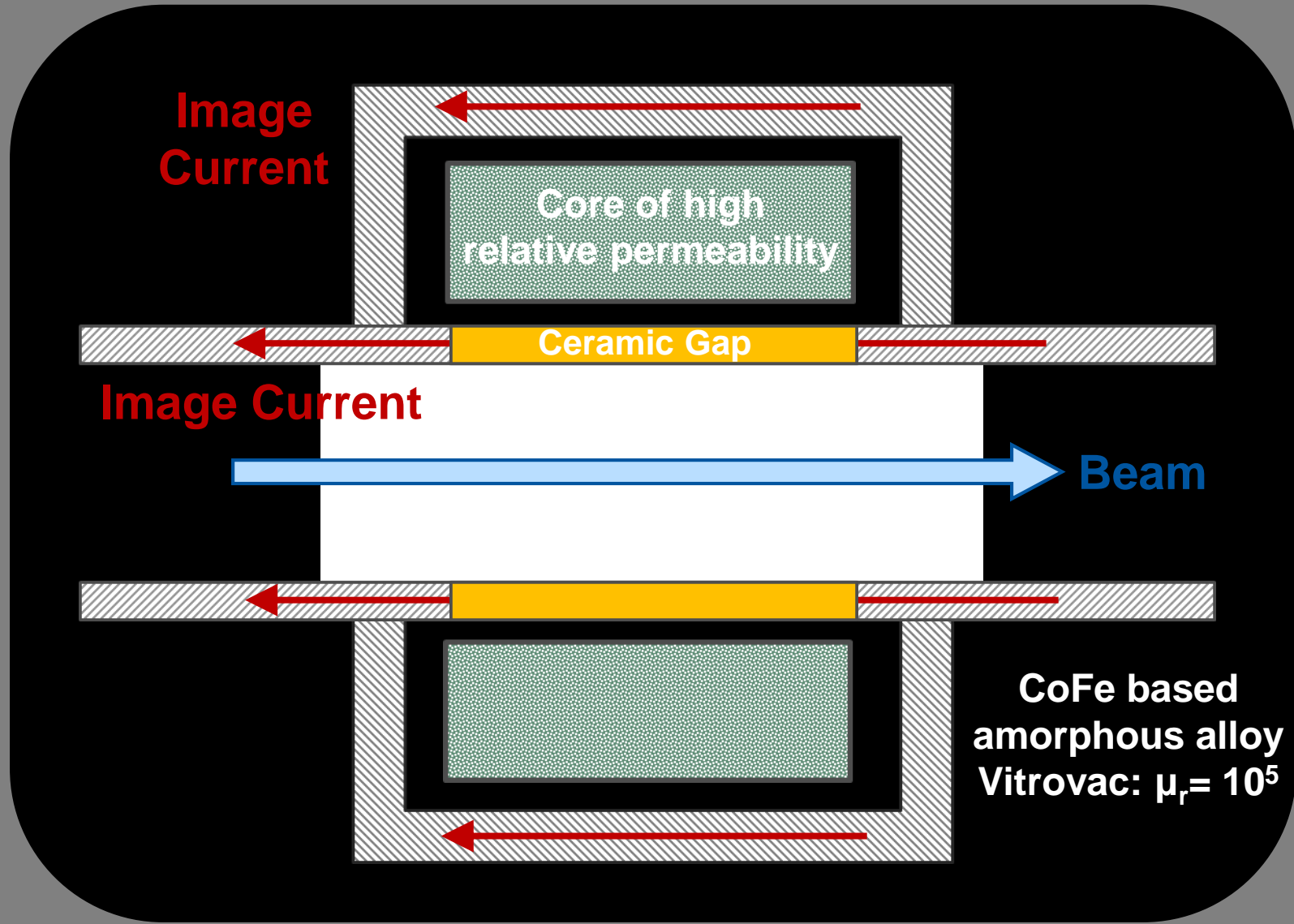
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- **Beam Intensity**
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- Beam Profile
  - secondary emission grids and screens
  - wire scanners
  - synchrotron light monitors
  - ionization and luminescence monitors
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- Beam Loss
  - ionization chambers or pin diodes
- Machine Tune and Chromaticity (derived quantities)



# Wall Current Monitor – The Principle

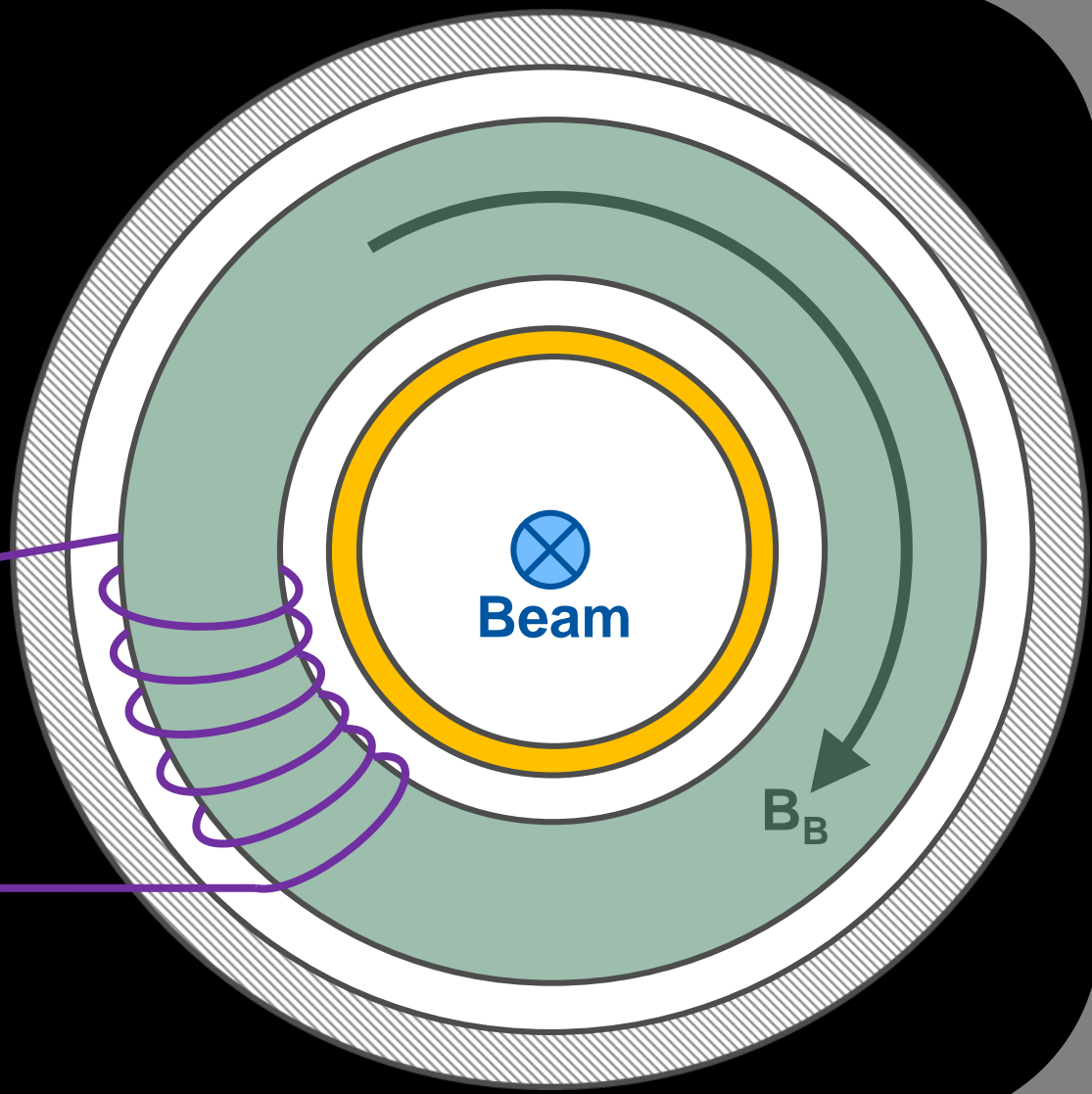
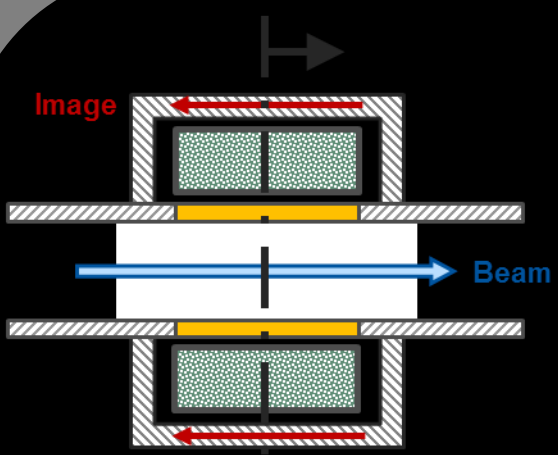


# AC (Fast) Current Transformers



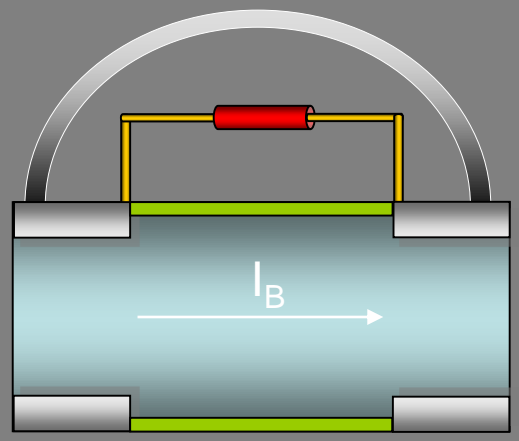
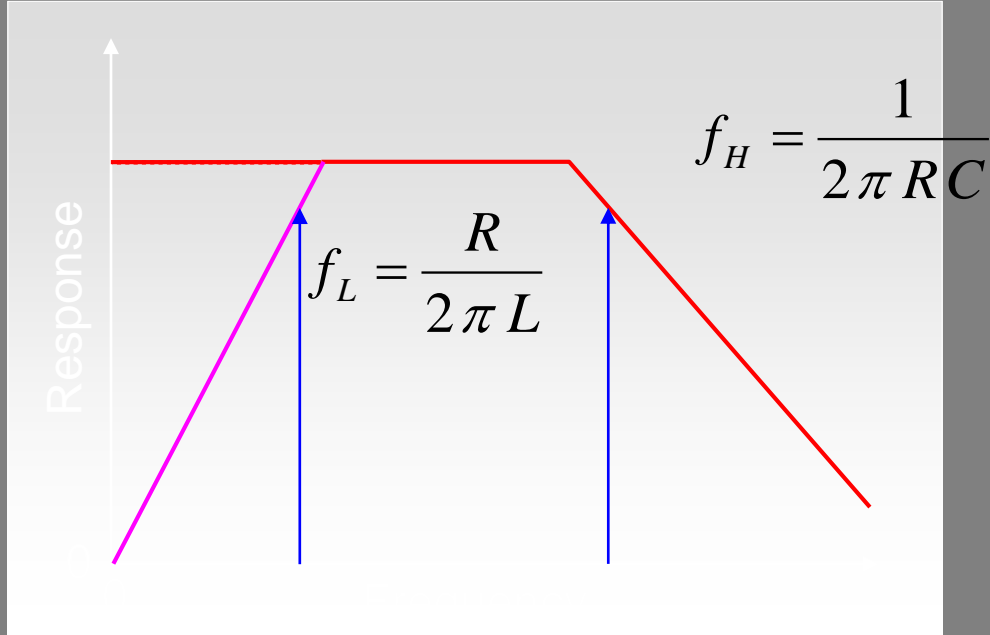
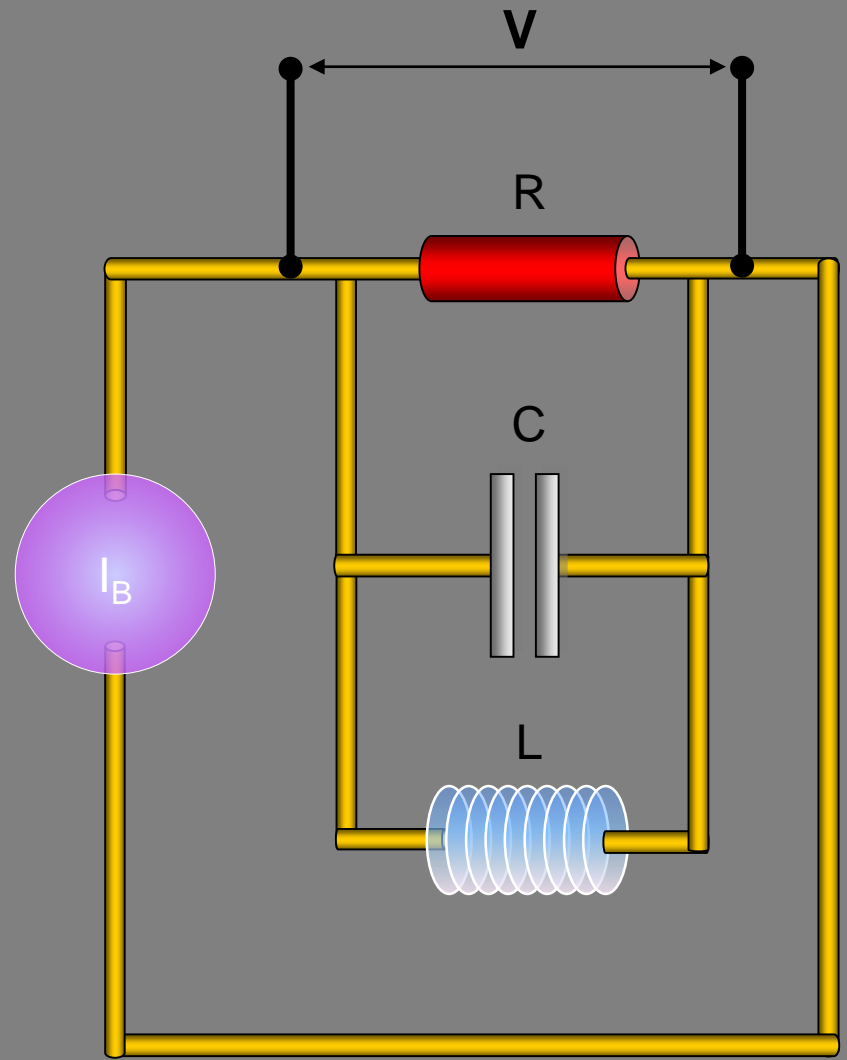


# AC (Fast) Current Transformers





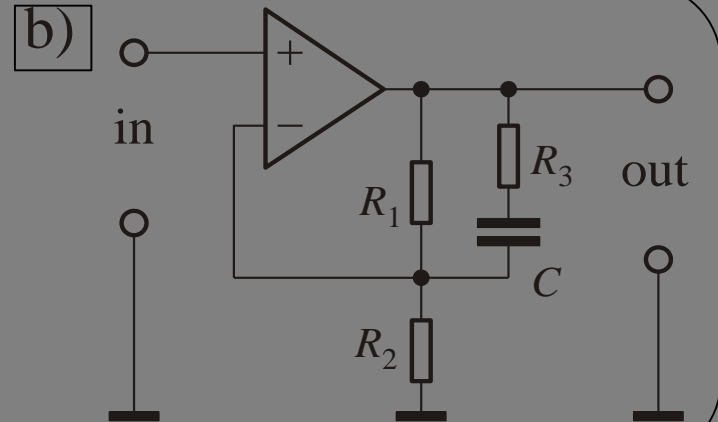
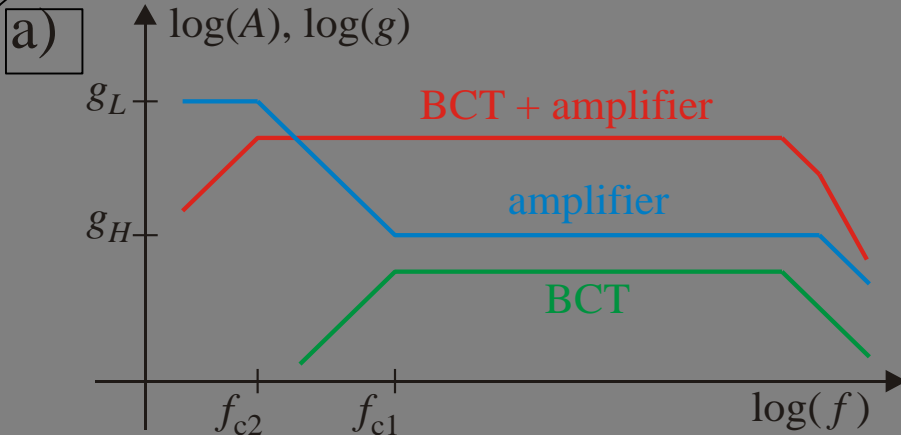
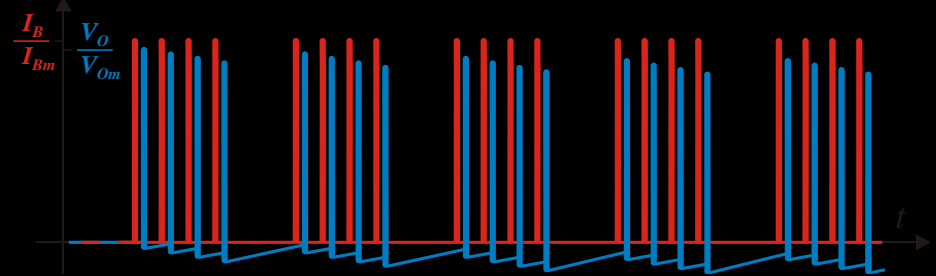
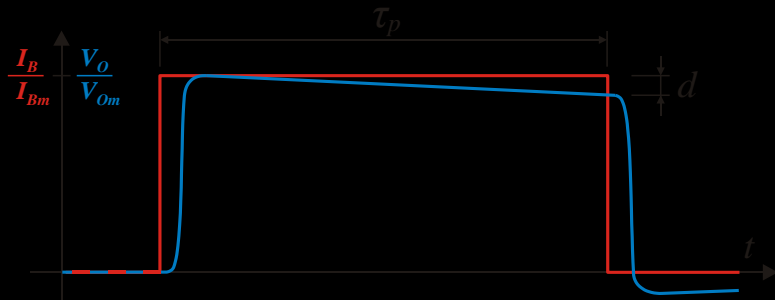
# Wall Current Monitor – Beam Response



# AC (Fast) Transformer Response

- Low cut-off

- Impedance of secondary winding decreases at low frequency
- Results in signal droop and baseline shift
- Mitigated by baseline restoration techniques (analogue or digital)





# What one can do with such a System

SPS Bunch to Bunch Position Measurement Interface - FSTBCT-06092002-PROTON2-0ms-MTG#1.txt

File Settings Drawing Options Help

Acquisition: **Multi Acquisition**

Acquisition Time: 0 ms

First Bunch: 1

Number of Bunches: 72

Number of Turns: 1

**Start Acquisition**

**Start Repeat** **Stop Repeat**

Dataviewer Control:

**Batch Evolution**

Trace 1 on Dataviewer: 2, 9 ms

Trace 2 on Dataviewer: 2, 9 ms

Turn on Dataviewer: 1

CERN/SL XDataviewer 6.4 ZOOMIN:Pick first point Kick Clean Reverse

Views Subview External Editor Select

Plot Grid OFF Zeroline OFF OP ONE Zoom In Box

Profiles 06/09/02 17:07:19

Bunch Intensity -3.6 Bunch 74.6

Turn 1

Da 48.0000 0.0056 dy -0.1297 Cu 47.8789 -0.1241 pl\_trace1

**2D View** **3D View** **Dataviewer**

Ready ...

Bad RF Capture of a single LHC Batch in the SPS (72 bunches)



# The Typical Instruments

---

- Beam Position
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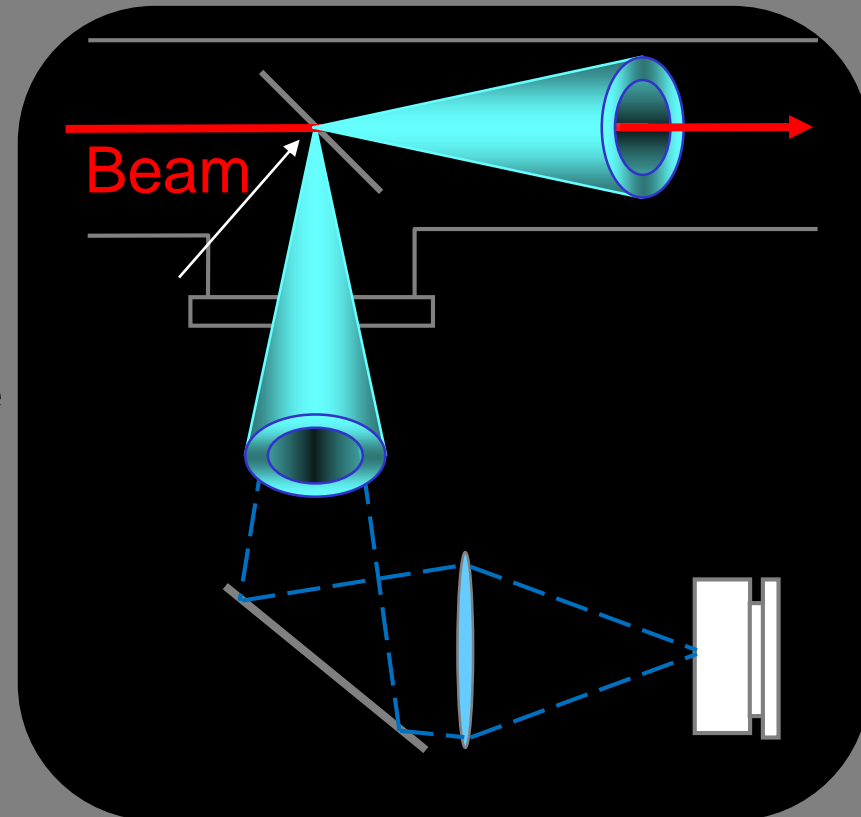
# Beam Profile Monitoring using Screens

- **Screen Types**

- Luminescence / Scintillating Screens
  - Destructive (thick) but work with low intensities
- Optical Transition Radiation (OTR) screens
  - Much less destructive (thin) but require higher energy / intensity beam

- **OTR**

- Radiation emitted when a charged particle goes through an interface with different dielectric constants
- Surface phenomenon allows use of very thin screens ( $\sim 10\mu\text{m}$ )
  - Can use multiple screens with single pass in transfer lines
  - Can leave it in for hundreds of turns e.g. for injection matching

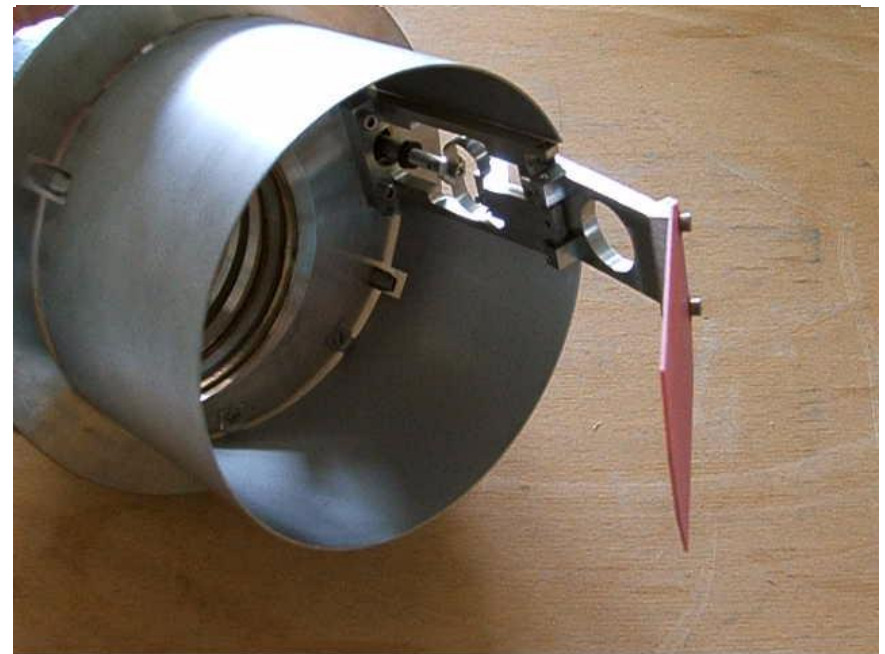




# Screen mechanism

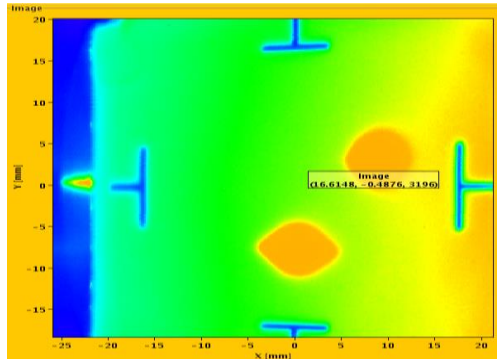


- Screen with graticule

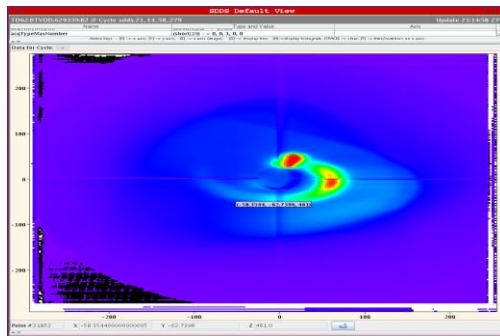




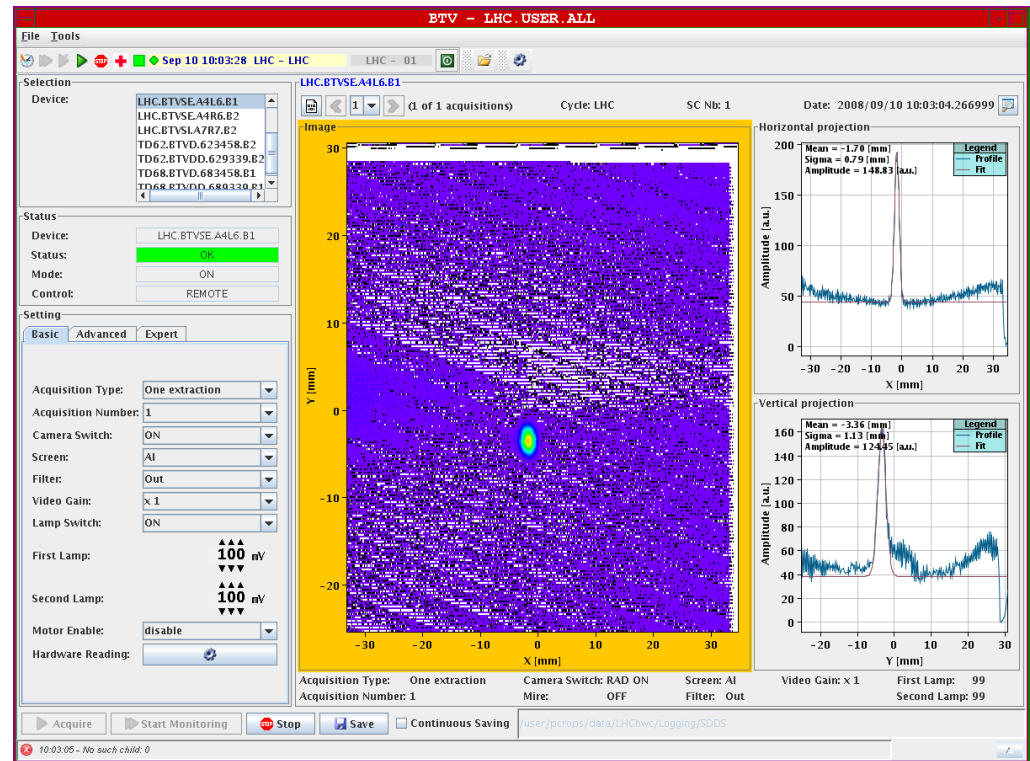
# Results from TV Frame grabber



First full turn  
as seen by the  
BTV  
10/9/2008



Un-captured  
beam sweeps  
through the  
dump line



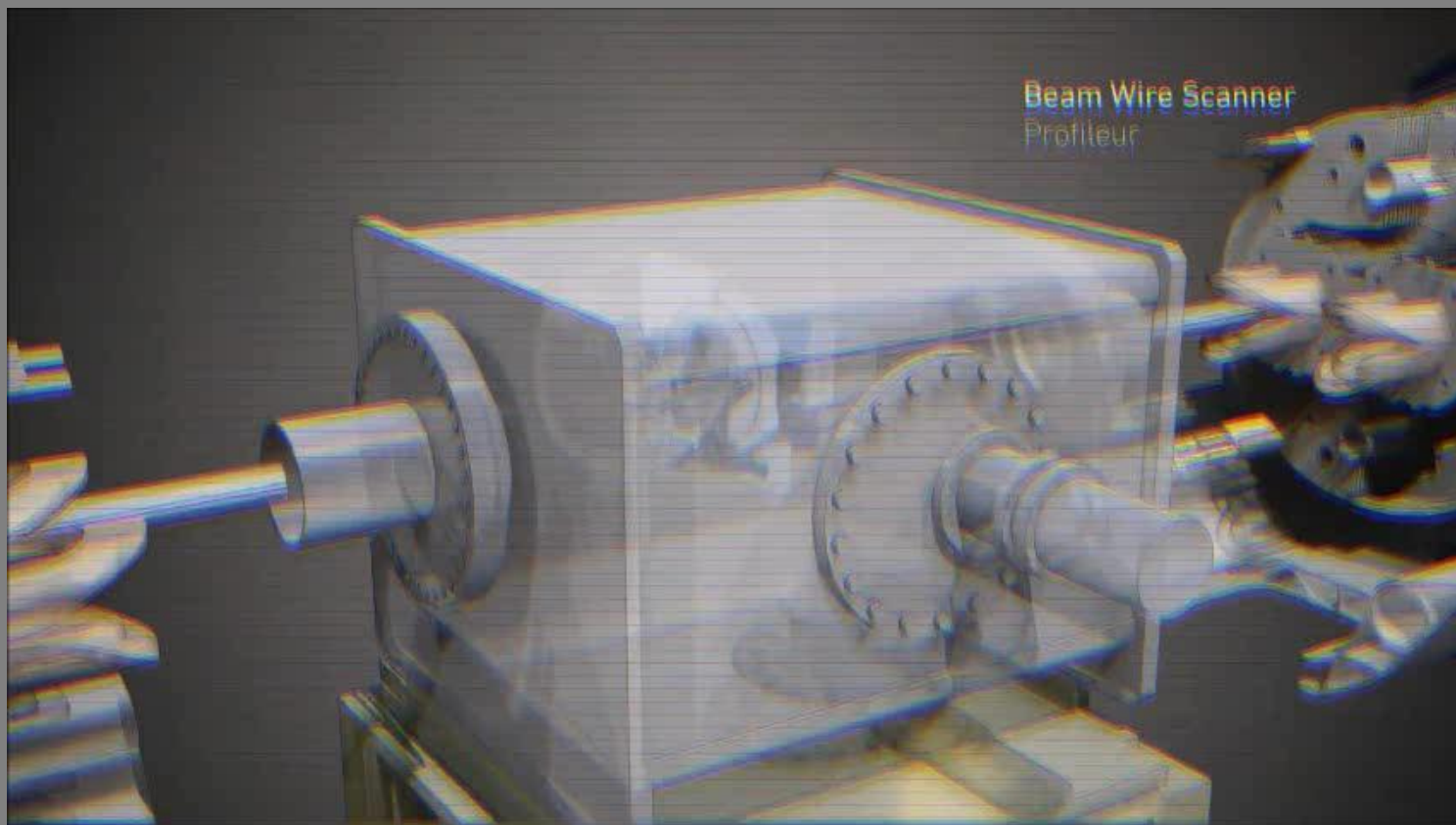
- For further evaluation the video signal is digitized, read-out and treated by program



# Beam Profile Monitoring using Wire-Scanners

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- A thin wire is moved across the beam
  - Has to move fast to avoid excessive heating of the wire
- Detection
  - Secondary particle shower detected outside vacuum chamber using scintillator/photo-multiplier
- Correlating wire position with detected signal gives the beam profile



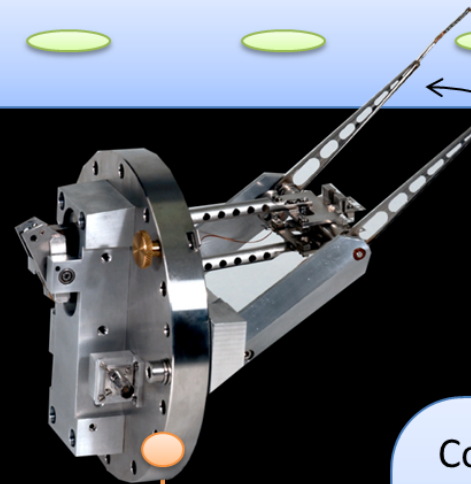


# Beam Profile Monitoring using Wire-Scanners

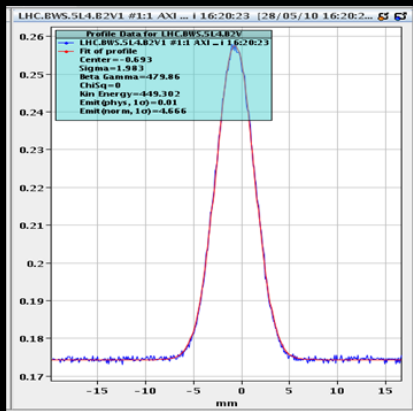
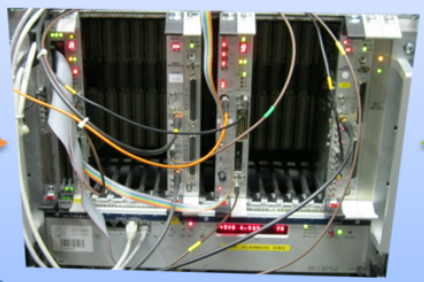
Vacuum tube

Particle beam

Secondary Particles generated by beam interactions with the wire

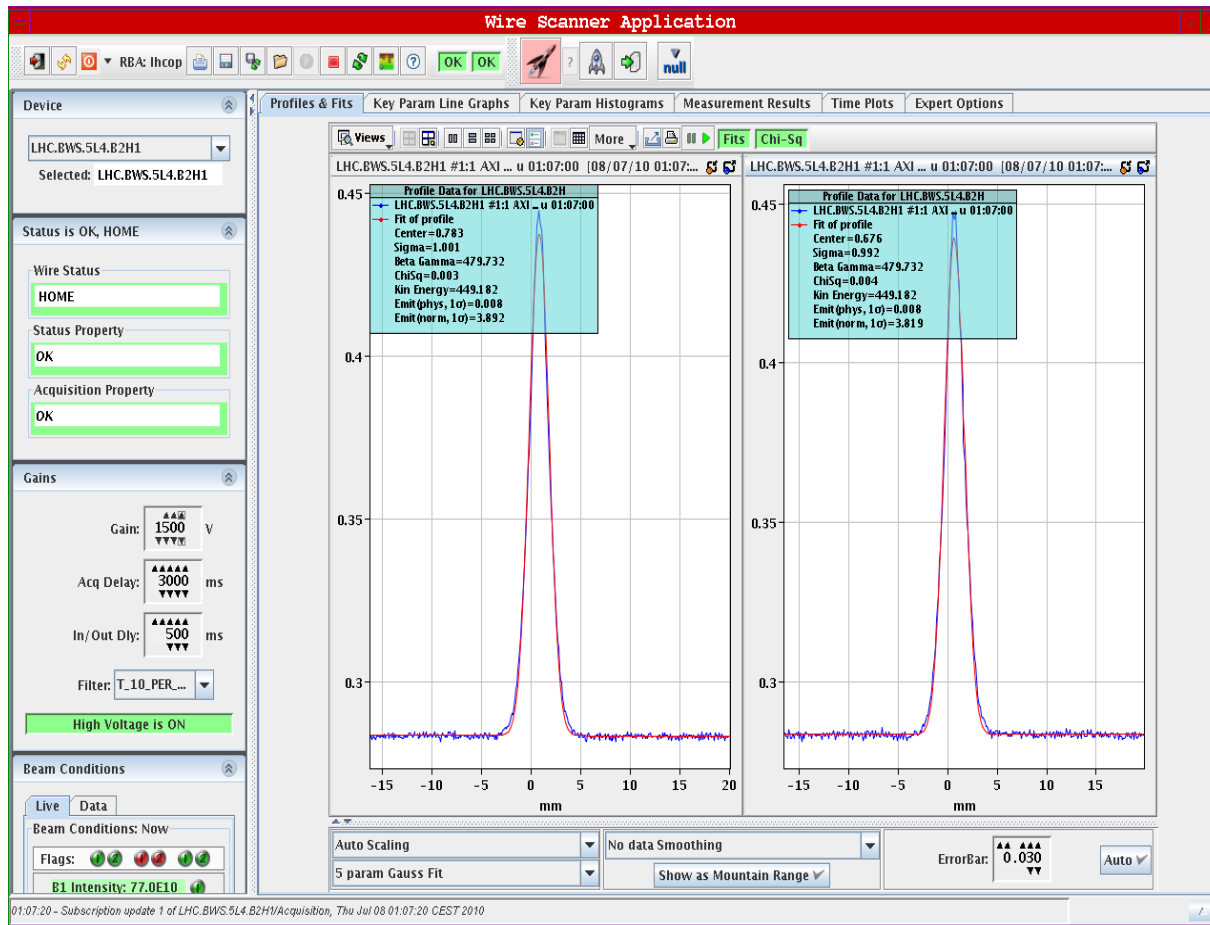


Control and acquisition Electronics





# Wire scanner profile



High speed needed because of heating.

Adiabatic damping

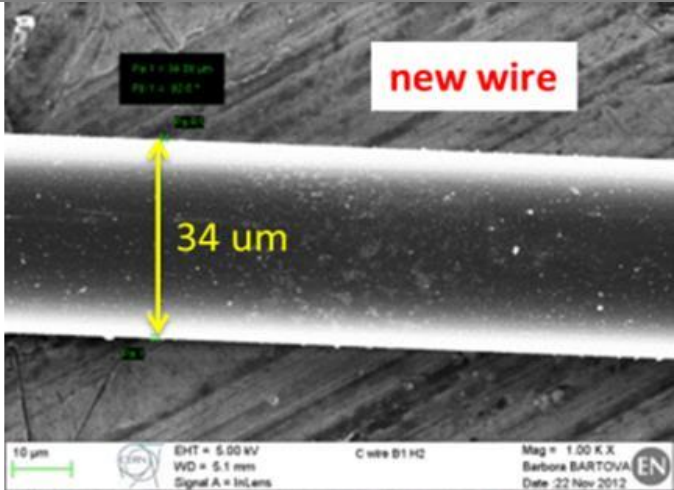
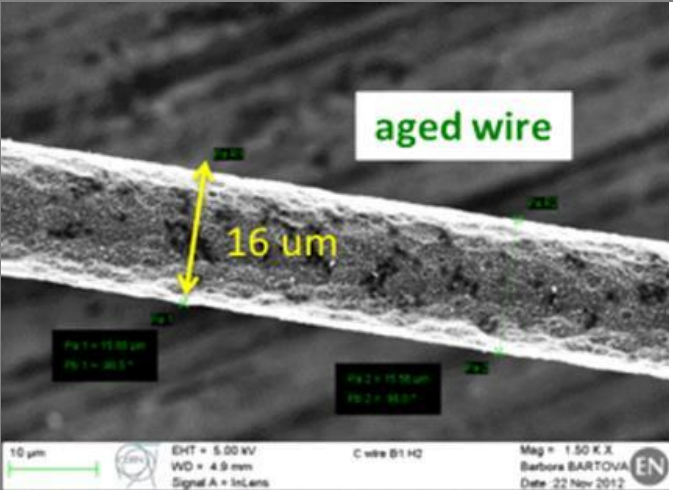
Current increase due to speed increase

Speeds of up to 20m/s  
=> 200g acceleration



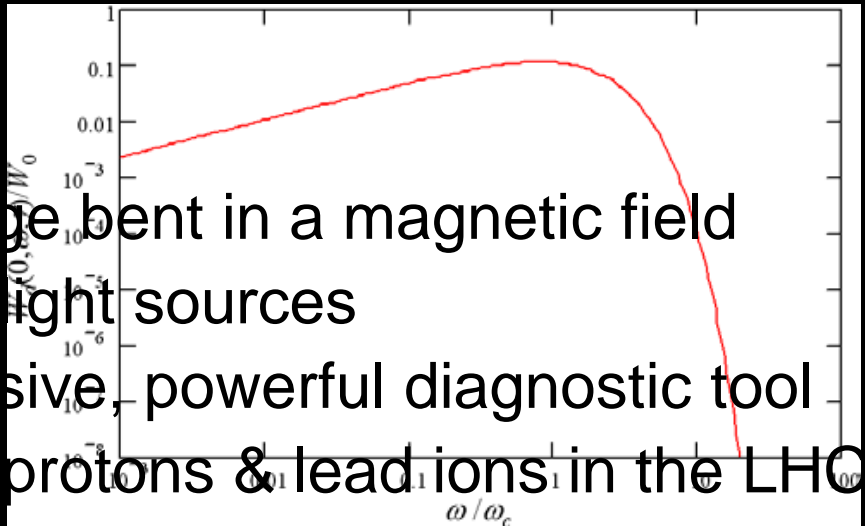
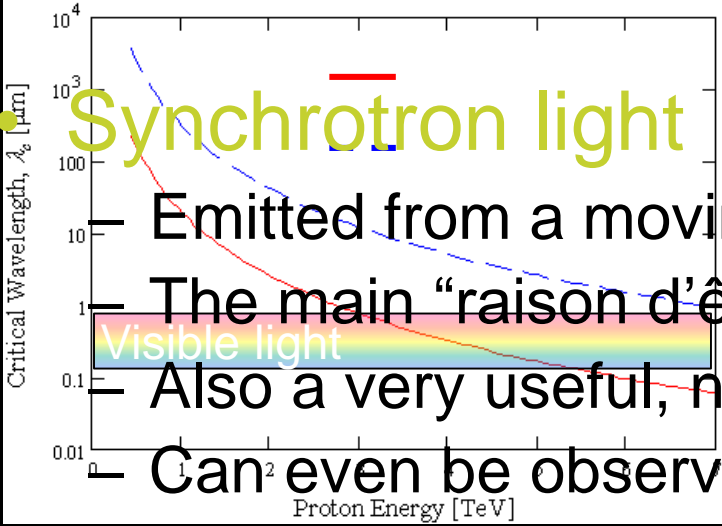
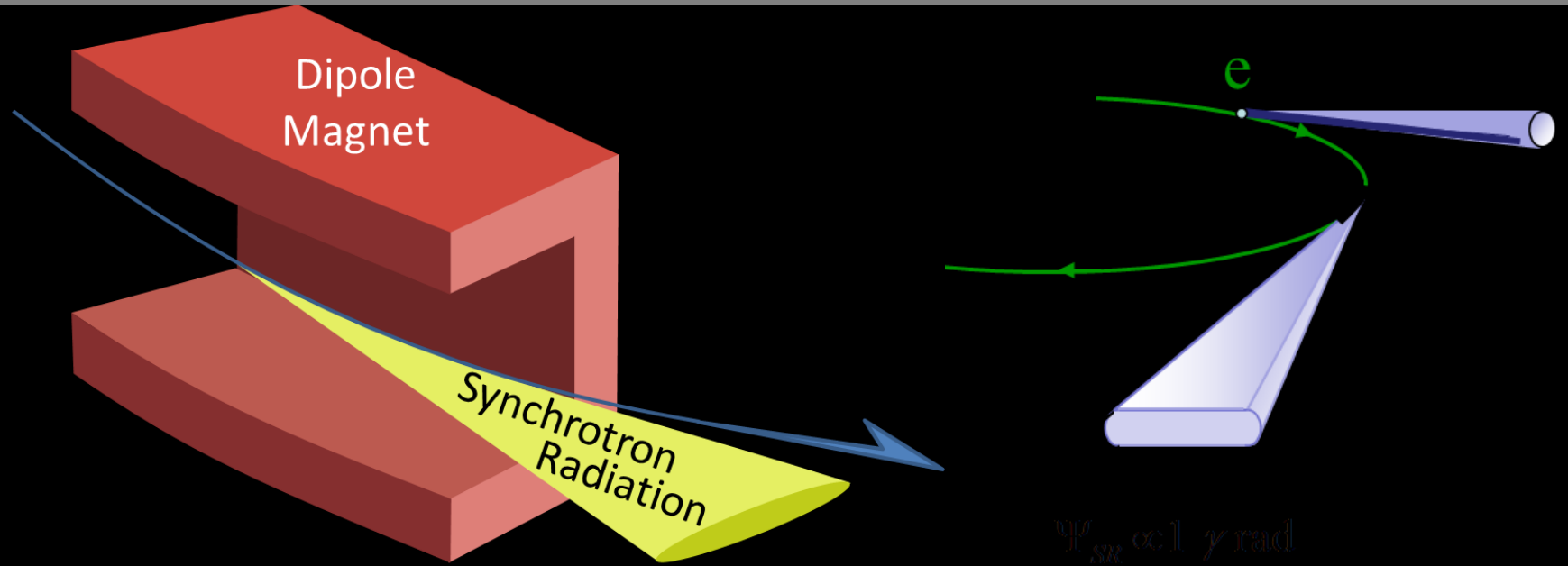
# Limitation of WireScanners

- **Wire Breakage – why?**
  - Brittle or Plastic failure (error in motor control)
  - Melting/Sublimation (main intensity limit)
    - Due to energy deposition in wire by proton beam
- **Temperature evolution depends on**
  - Heat capacity, which increases with temperature!
  - Cooling (radiative, conductive, thermionic, sublimation)
    - Negligible during measurements (Typical scan 1 ms & cooling time constant ~10-15 ms)
- **Wire Choice**
  - Good mechanical properties, high heat capacity, high melting/sublimation point
  - E.g. Carbon which sublimates at 3915K





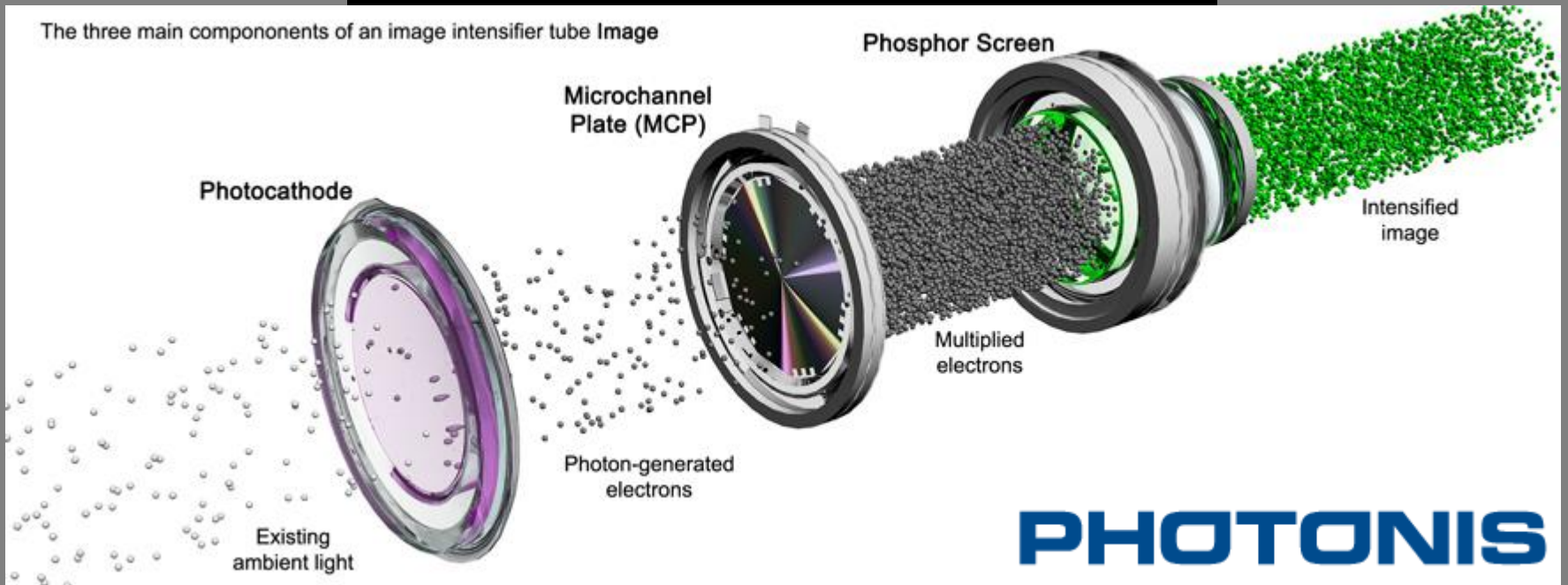
# Synchrotron Light Monitors



# Synchrotron Light Image Acquisition

- Using various cameras

- Standard CCD cameras for average beam size measurements
- Gated intensified camera
  - For bunch by bunch diagnostics
- Streak cameras
  - For short bunch diagnostics



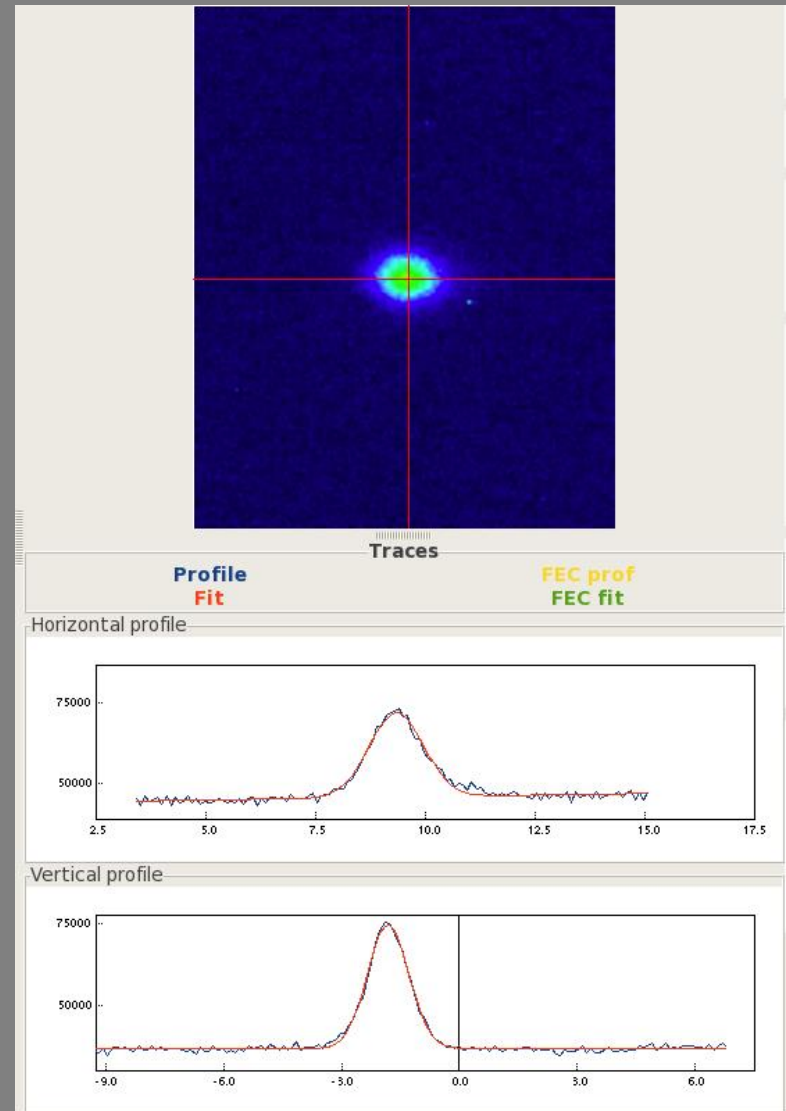
# Synchrotron Light Imaging

- Proton Beam Example

- LHC single bunch  
~1.1e11p @ 3.5 TeV
- Acquisition accumulated over 4 turns at 200Hz

- Limitations

- Aberrations
  - Mitigated by careful design
- Diffraction
  - Need to go to lower wavelengths as the beam size becomes smaller



# Measuring Ultra Short Bunches

- Next Generation FELs & Linear Colliders

- Use ultra short bunches to increase brightness or improve luminosity

- How do we measure such short bunches?

- Direct Observation

- Produce light & observe with dedicated instruments
    - Use of RF techniques
    - Use laser pulses and sampling techniques

- Indirect Calculation

- Reconstruct bunch length from frequency spectrum
      - Either directly from the bunch or through its radiation spectrum

p <sup>+</sup> @ LHC	250ps
H <sup>-</sup> @ SNS	100ps
e <sup>-</sup> @ ILC	500fs
e <sup>-</sup> @ CLIC	130fs
e <sup>-</sup> @ XFEL	80fs
e <sup>-</sup> @ LCLS	<75fs

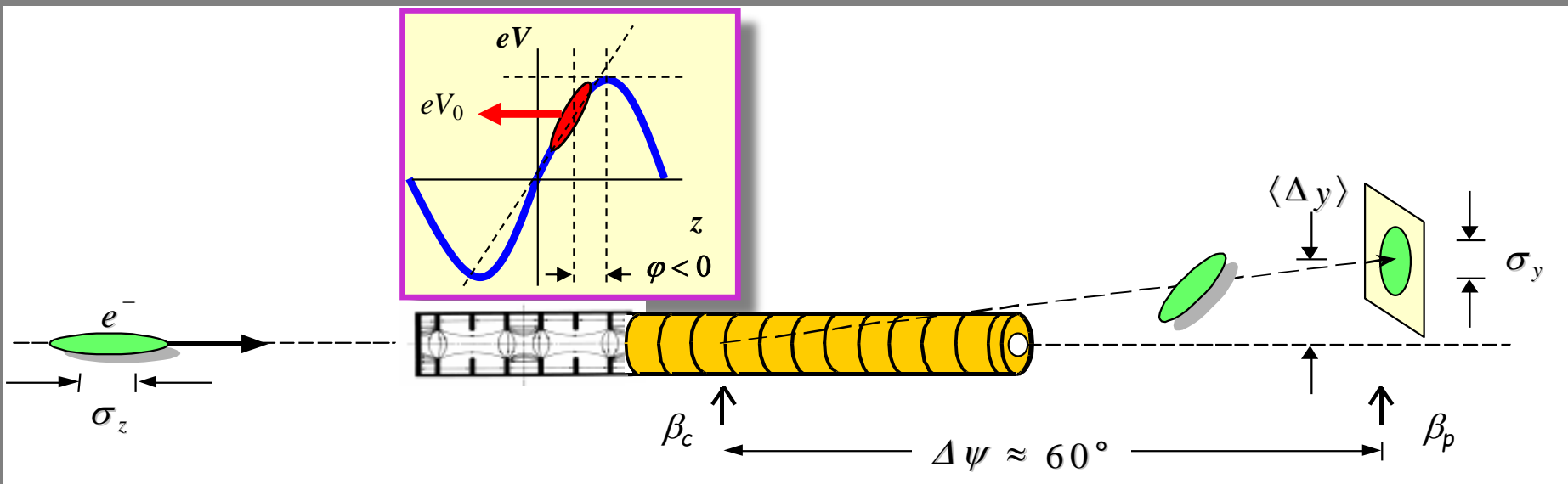
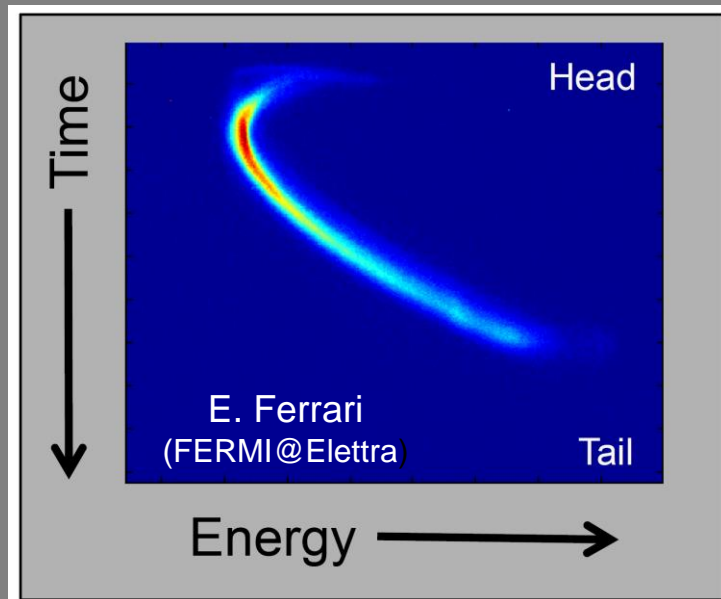
### Destructive Measurement



# Measuring Ultra Short Bunches

- **RF Deflection**

- Converts time information to spatial information
- Coupled to spectrometer also provides energy information
- Destructive technique
- Resolution down to 1.3 fs
  - X-band RF cavity
  - Linac Coherent Light Source (SLAC)



- Electro-Optic Sampling

## Polarization of Light Waves

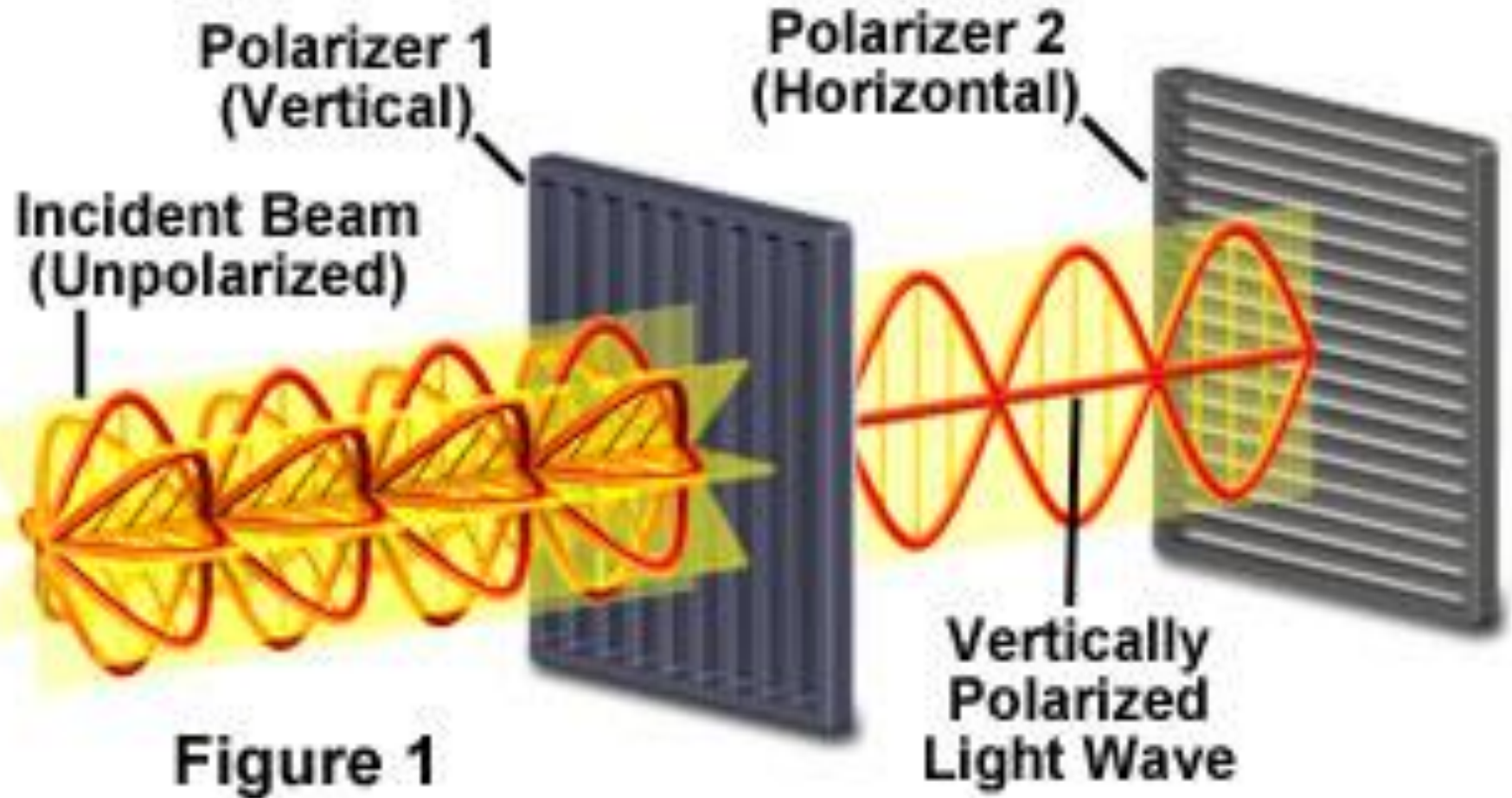


Figure 1



# The Typical Instruments

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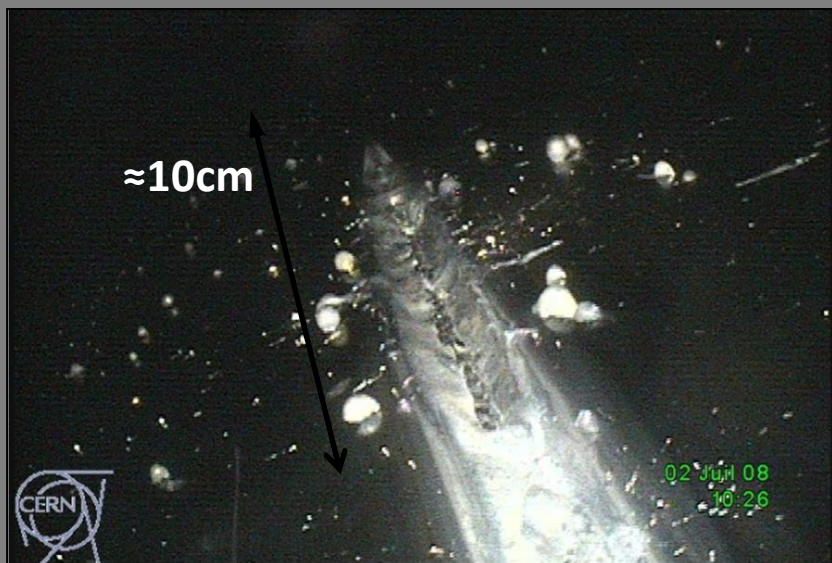
- Beam Position
  - electrostatic or electromagnetic pick-ups and related electronics
- Beam Intensity
  - beam current transformers
- Beam Profile
  - secondary emission grids and screens
  - wire scanners
  - synchrotron light monitors
  - ionization and luminescence monitors
  - femtosecond diagnostics for ultra short bunches
- **Beam Loss**
  - ionization chambers or pin diodes
- Machine Tune and Chromaticity (derived quantities)

# Beam Loss Detectors

- **Role of a BLM system:**
  - Protect the machine from damage
  - Dump the beam to avoid magnet quenches (for SC magnets)
  - Diagnostic tool to improve the performance of the accelerator
- **E.g. LHC**

Stored Energy	
Beam 7 TeV	2 x 362 MJ
2011 Beam 3.5 TeV	above 2 x 100 MJ

Quench and Damage at 7 TeV	
Quench level	$\approx 1 \text{ mJ/cm}^3$
Damage level	$\approx 1 \text{ J/cm}^3$



- **SPS incident**
  - June 2008
  - 2 MJ beam lost at 400GeV

# Beam Loss Detectors

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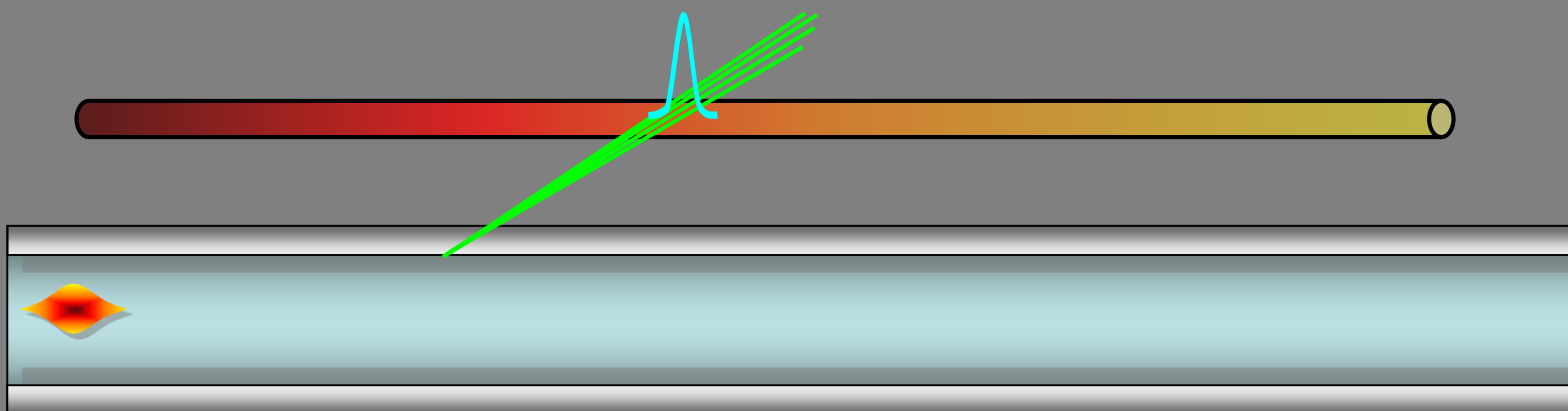
- Common types of monitor

- Long ionisation chamber (charge detection)

- Up to several km of gas filled hollow coaxial cables
- Position sensitivity achieved by comparing direct & reflected pulse
  - e.g. SLAC – 8m position resolution (30ns) over 3.5km cable length
- Dynamic range of up to  $10^4$

- Fibre optic monitors

- Electrical signals replaced by light produced through Cerenkov effect

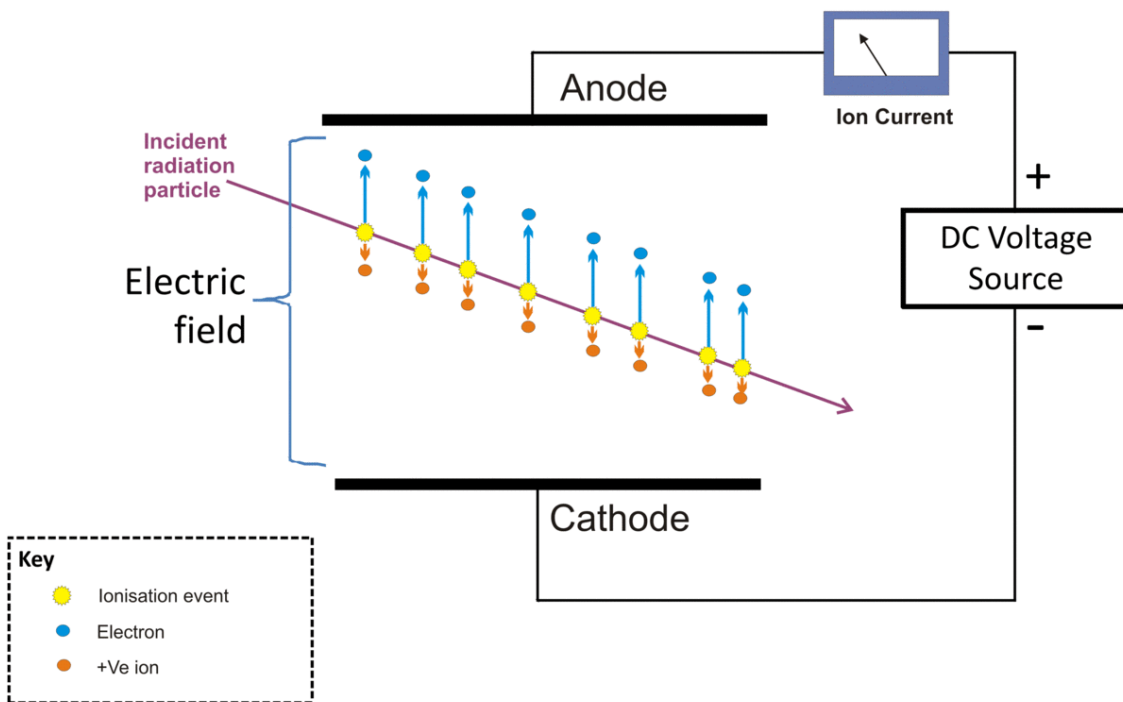


# Beam Loss Detectors

- Common types of monitor

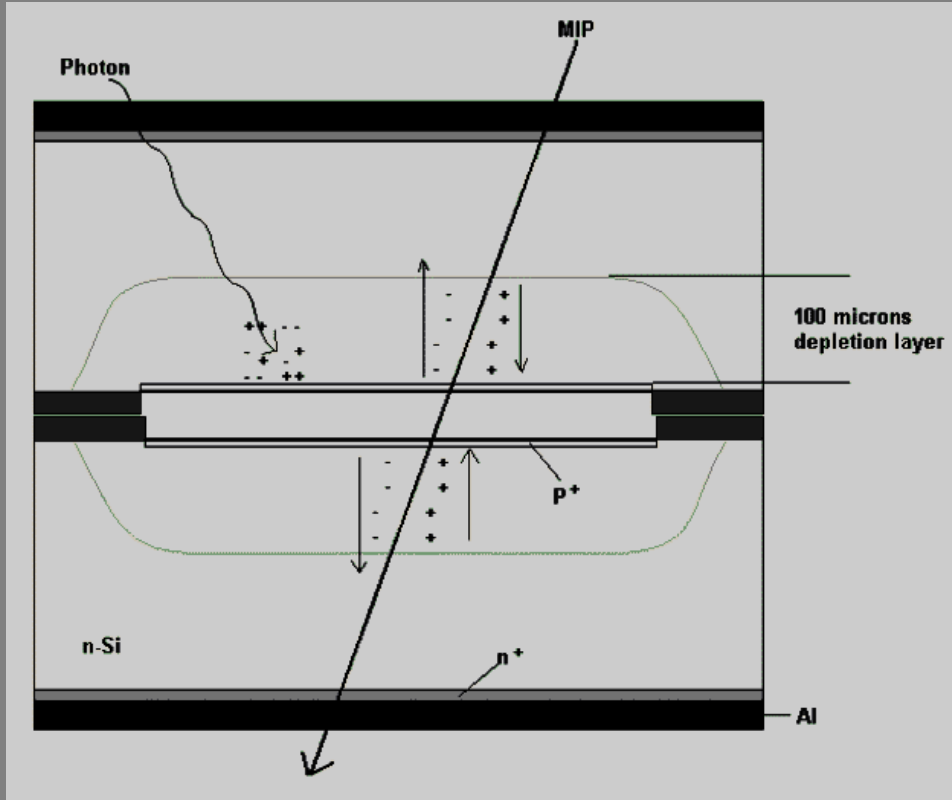
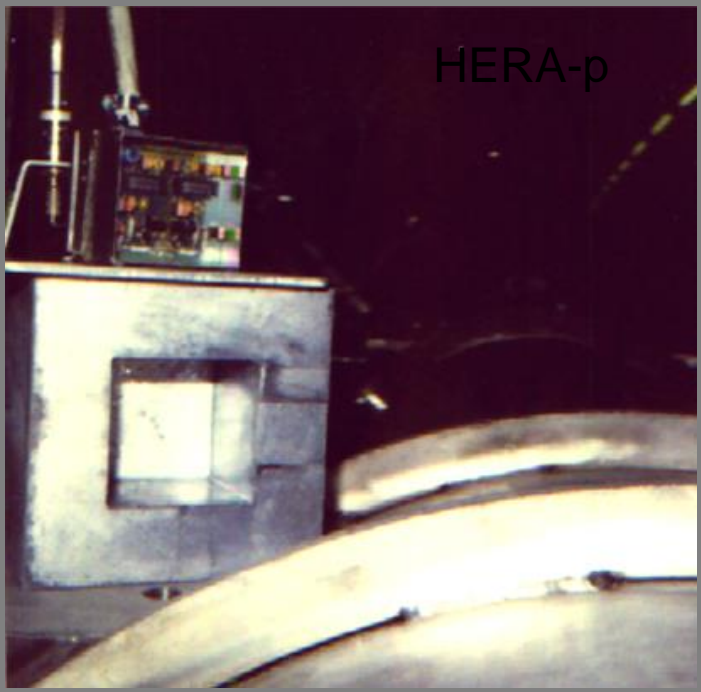
- Ionisation chambers
- Dynamic range of  $< 10^8$
- Slow response ( $\mu\text{s}$ ) due to ion drift time

## Visualisation of ion chamber operation



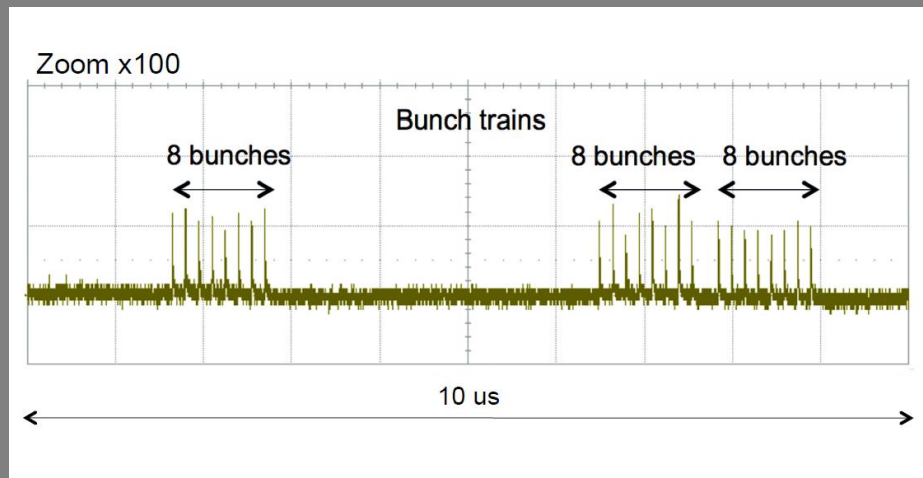
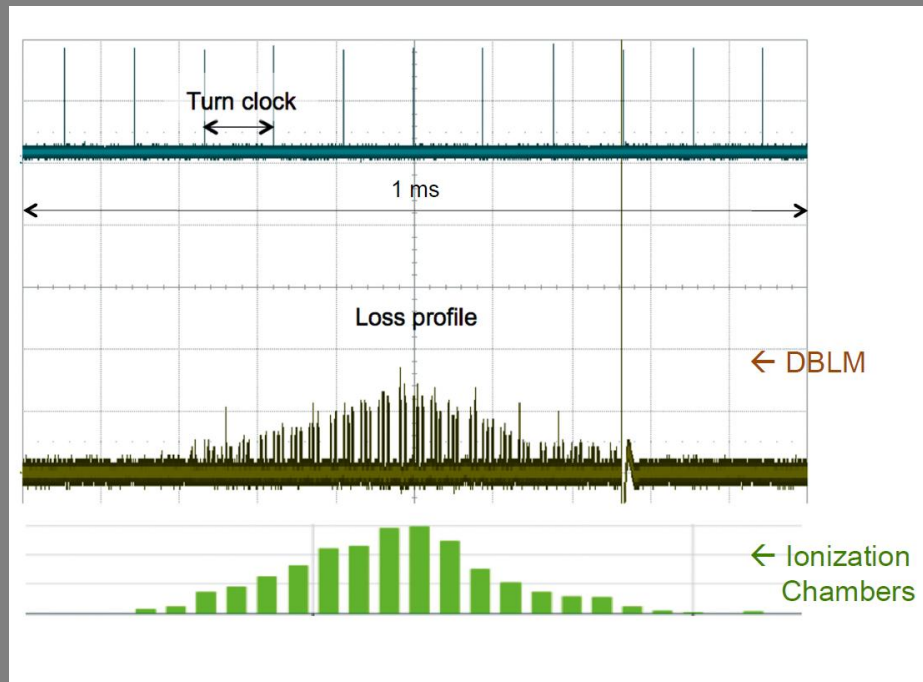
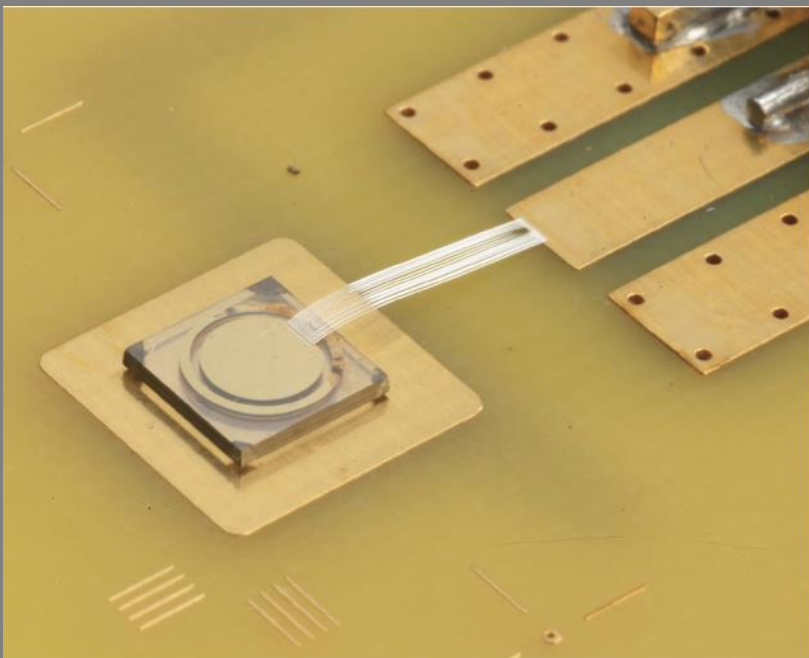
# Beam Loss Detectors

- Common types of monitor
  - PIN photodiode (solid state ionisation chamber)
    - Detect coincidence of ionising particle crossing photodiodes
    - Count rate proportional to beam loss with speed limited by integration time
    - Can distinguish between X-rays & ionising particles
    - Dynamic range of up to  $10^9$



# Beam Loss Detectors – New Materials

- **Diamond Detectors**
  - Fast & sensitive
  - Used in LHC to distinguish bunch by bunch losses
  - Investigations now ongoing to see if they can work in cryogenic conditions







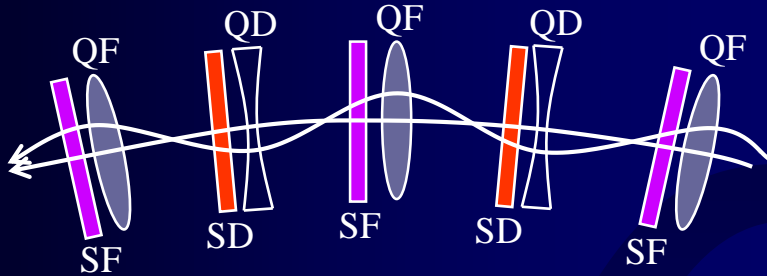
# The Typical Instruments

---

- Beam Position
  - electrostatic or electromagnetic pick-ups and related electronics
- Beam Intensity
  - beam current transformers
- Beam Profile
  - secondary emission grids and screens
  - wire scanners
  - synchrotron light monitors
  - ionization and luminescence monitors
  - femtosecond diagnostics for ultra short bunches
- Beam Loss
  - ionization chambers or pin diodes
- Machine Tune and Chromaticity (derived quantities)



# Measurement of Q (betatron tune)



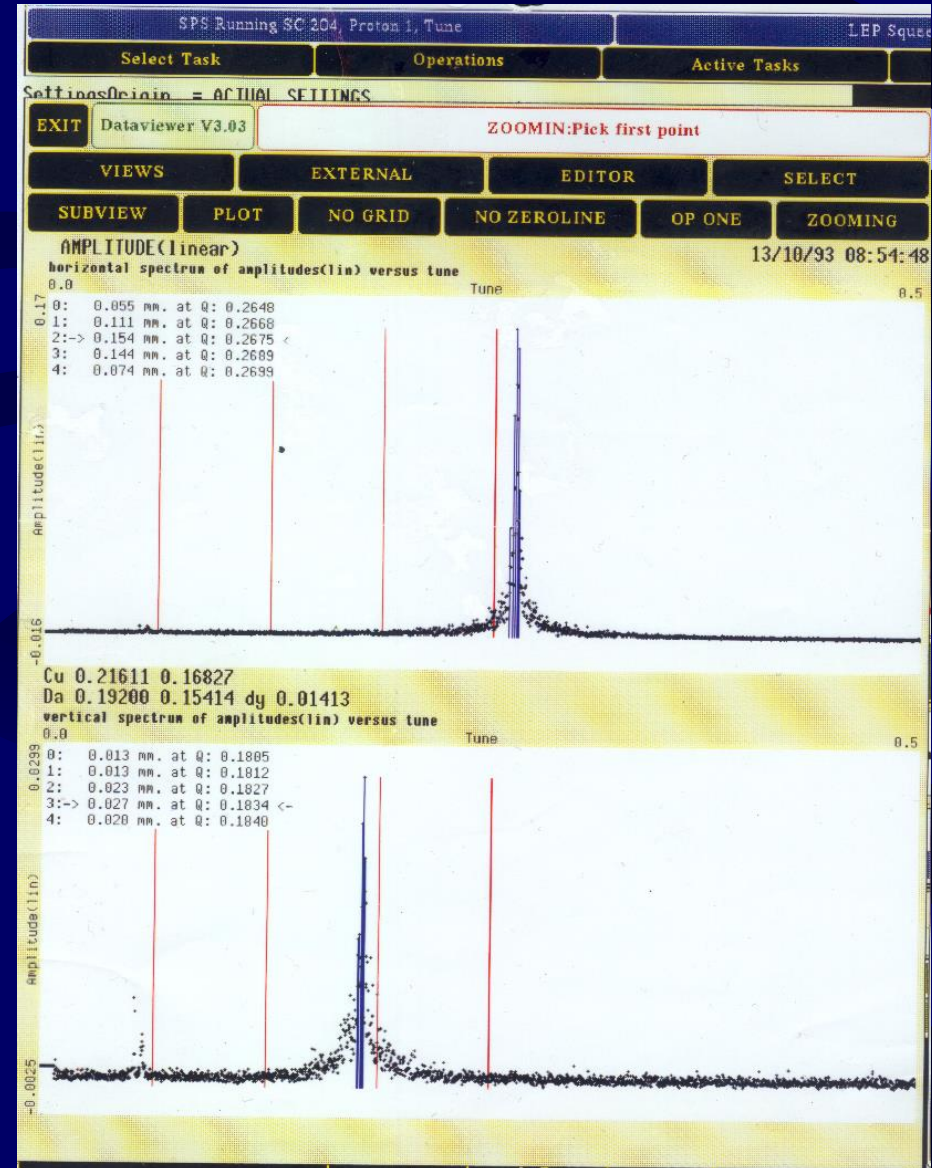
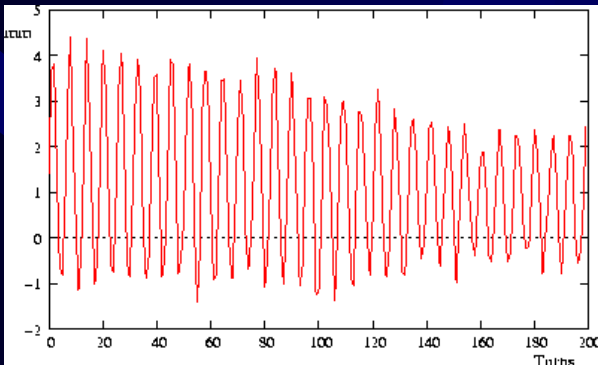
Characteristic Frequency  
of the Magnet Lattice  
Produced by the strength of the  
Quadrupole magnets

- **Q** – the eigenfrequency of betatron oscillations in a circular machine
  - One of the key parameters of machine operation
- **Many measurement methods available:**
  - different beam excitations
  - different observations of resulting beam oscillation
  - different data treatment



# Fourier analysis of turn by turn BPM measurements

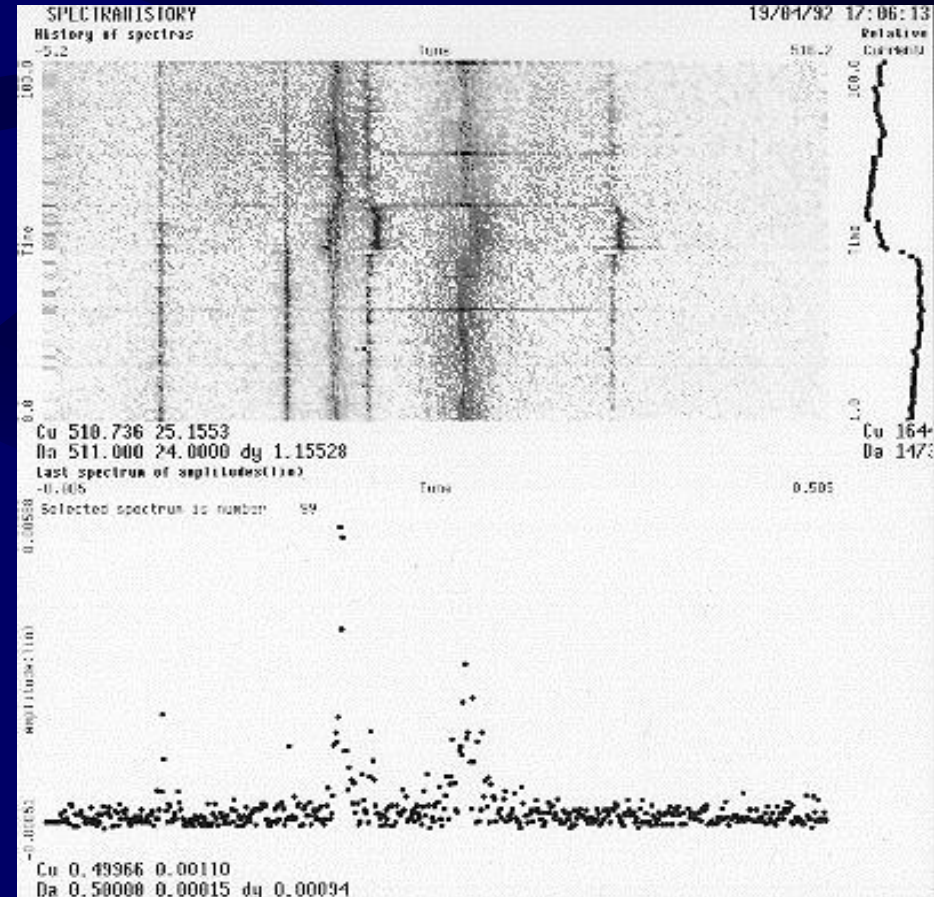
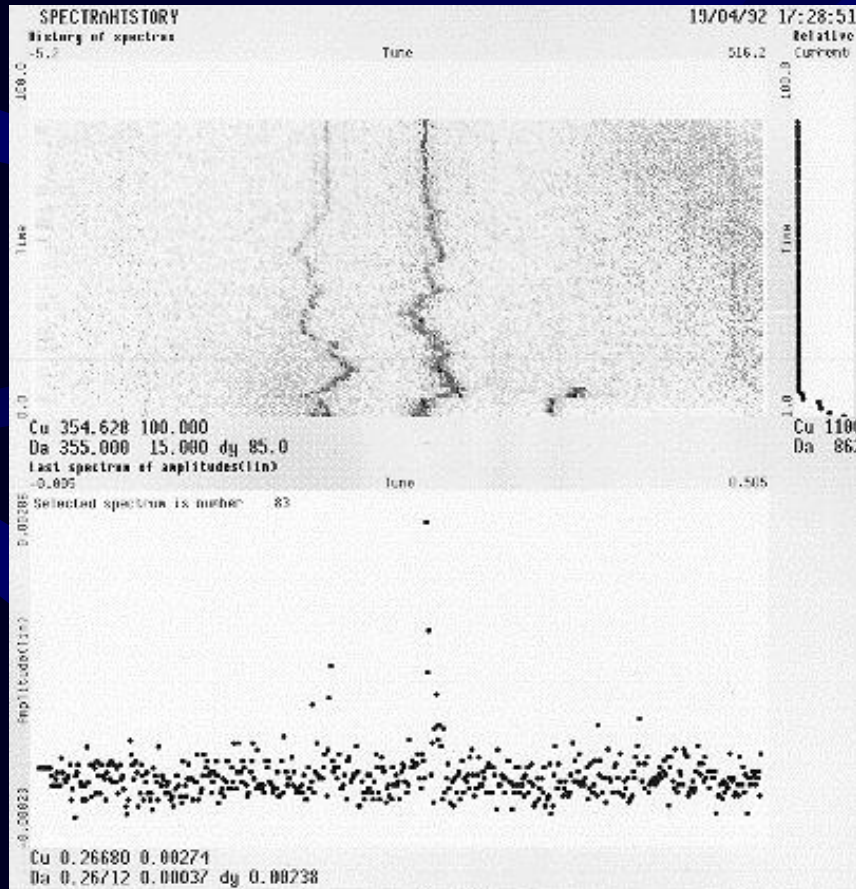
- 1) Stimulate transverse beam oscillation with a kicker magnet (short dipole kick during one revolution period)
- 2) Measure turn-by-turn beam position
- 3) Fourier transform of data
- 4) Tune: = maximum of frequency spectrum
- 5) Resolution:  $dq/q = 2/N_{\text{samp}}$
- 6) Problems:
  - single shot measurement
  - oscillation has to last during measurement
  - strong damping in some accelerators
  - large initial excitation (emittance growth in case of hadron beams)





# Time Resolved Measurements

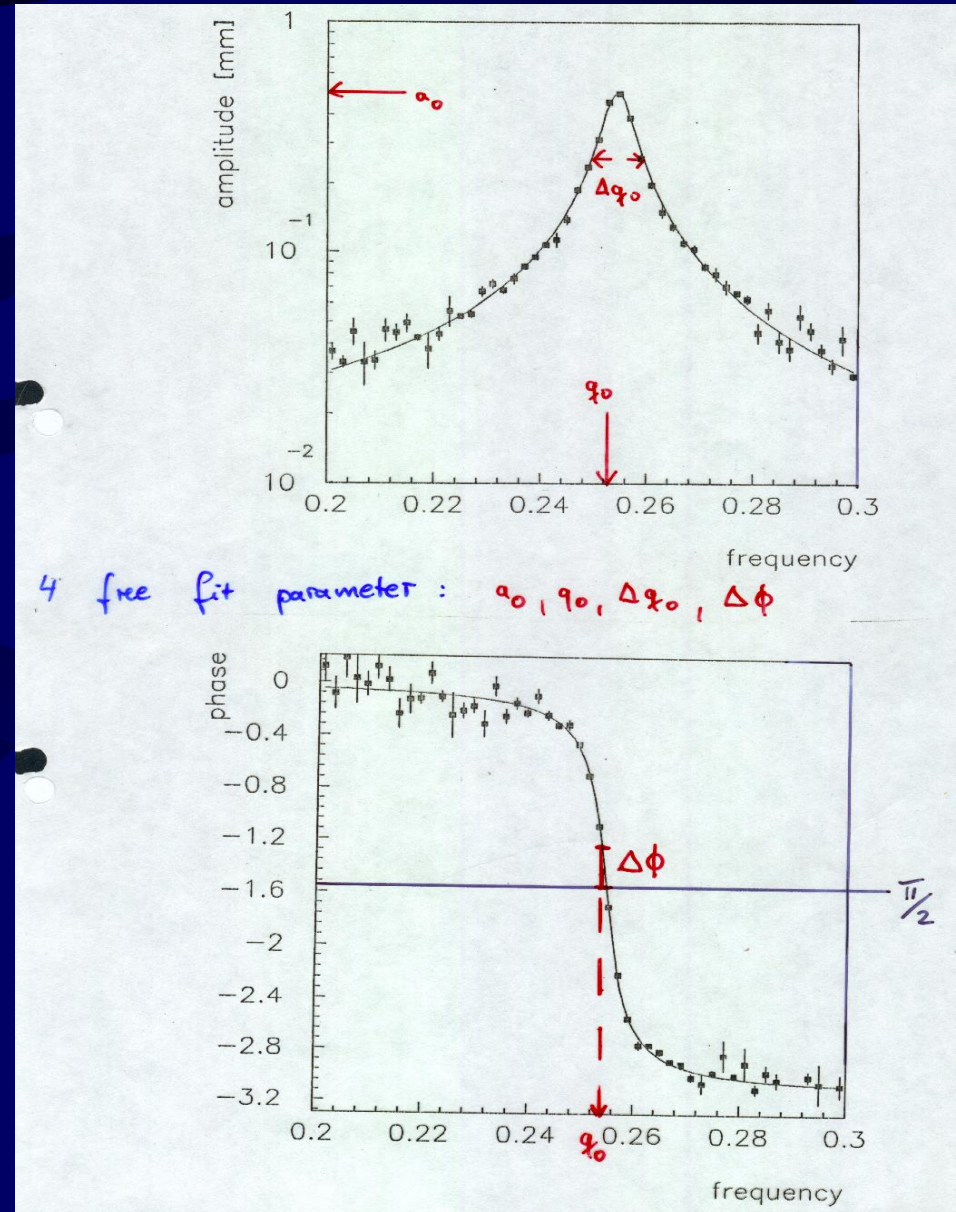
- To follow betatron tunes during machine transitions we need time resolved measurements. Simplest example:
  - repeated FFT spectra as before (spectrograms)





# Network Analysis

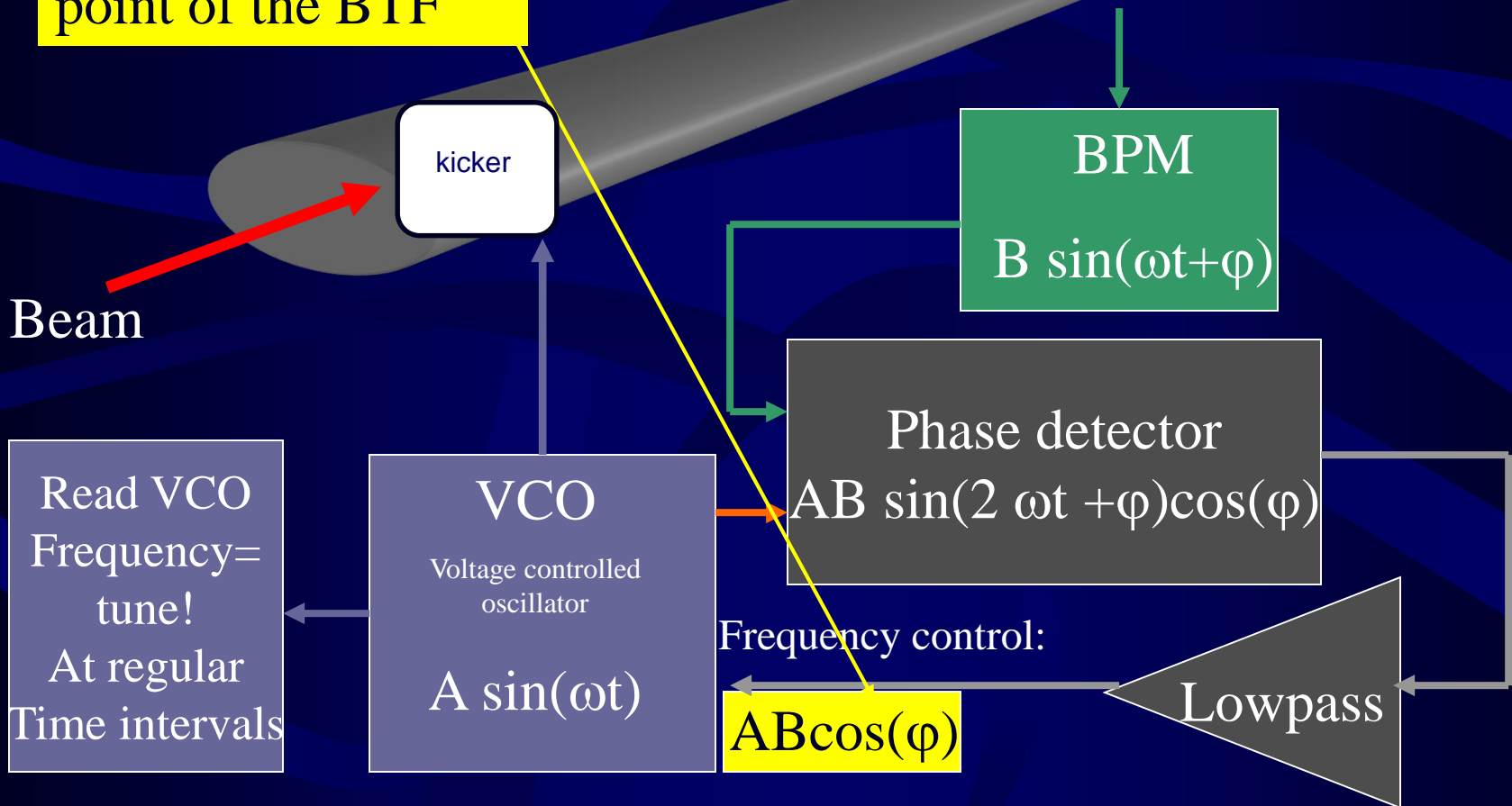
1. Excite beams with a sinusoidal carrier
2. Measure beam response
3. Sweep excitation frequency slowly through beam response





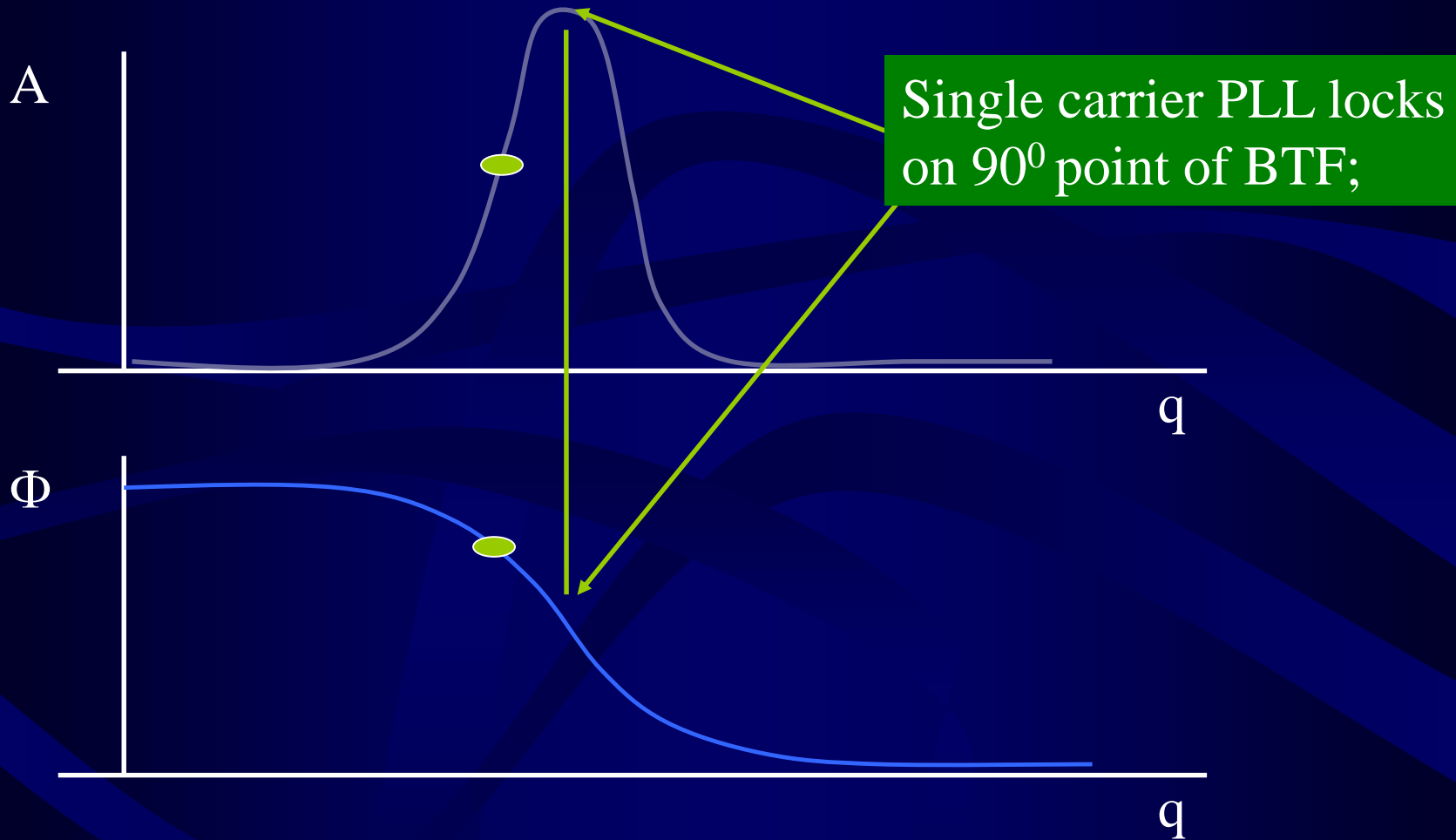
# Principle of PLL tune measurements

This PLL system looks to the 90 deg. point of the BTF



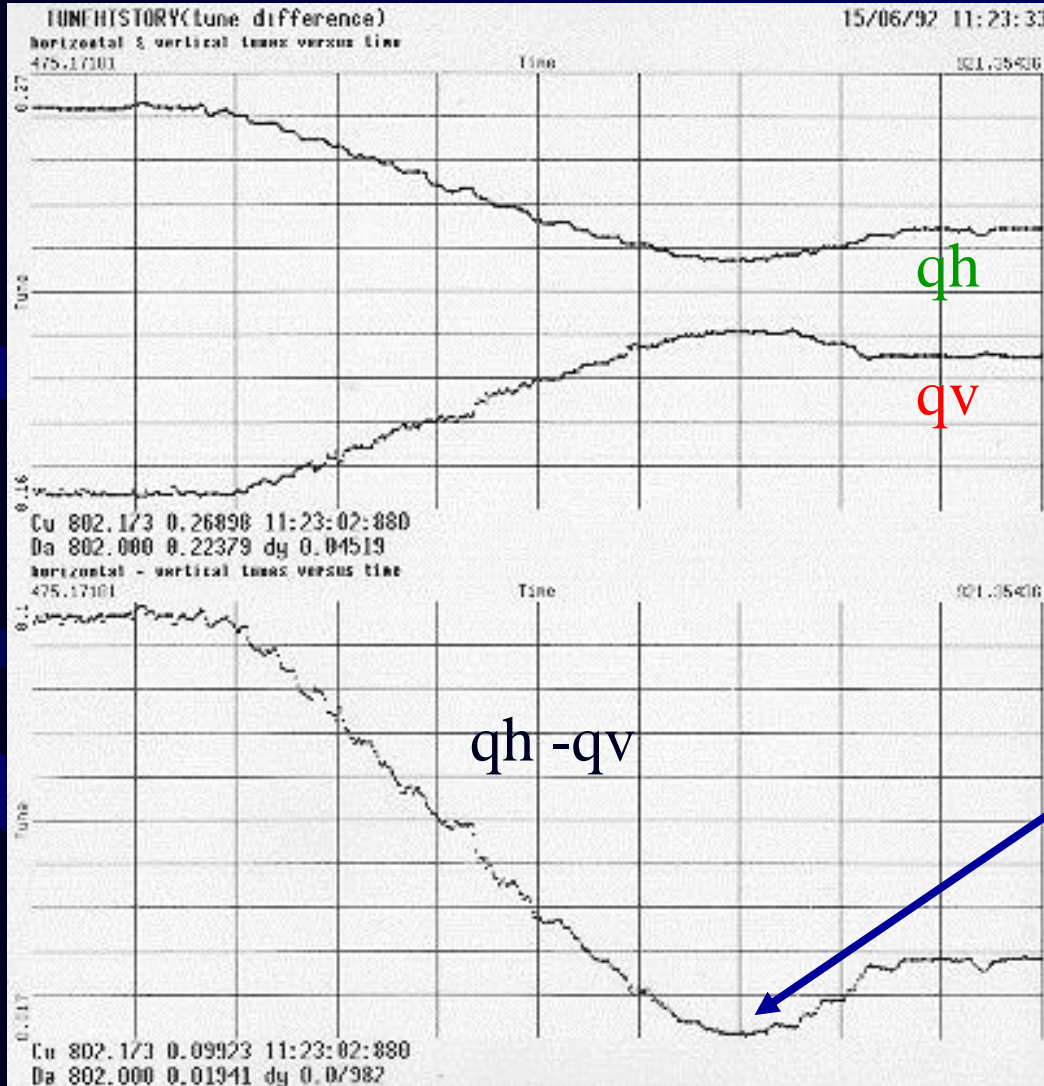


# Illustration of PLL tune tracking





# Example of PLL tune measurement



In this case continuous tune tracking was used whilst crossing the horizontal and vertical tunes with a power converter ramp.

Closest tune approach is a measure of coupling





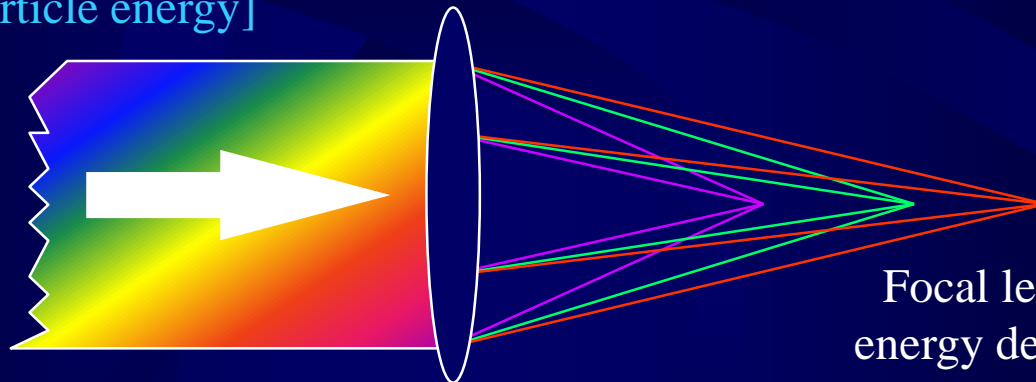
# Chromaticity ( $Q'$ or $\xi$ )

Spread in the Machine Tune  
due to Particle Energy Spread  
Controlled by Sextupole magnets

$$\Delta Q = Q' \frac{\Delta p}{p} = \left( \frac{1}{\gamma^2} - \alpha \right)^{-1} Q' \frac{\Delta f}{f}$$

## Optics Analogy:

Achromatic incident light  
[Spread in particle energy]



Lens

[Quadrupole]

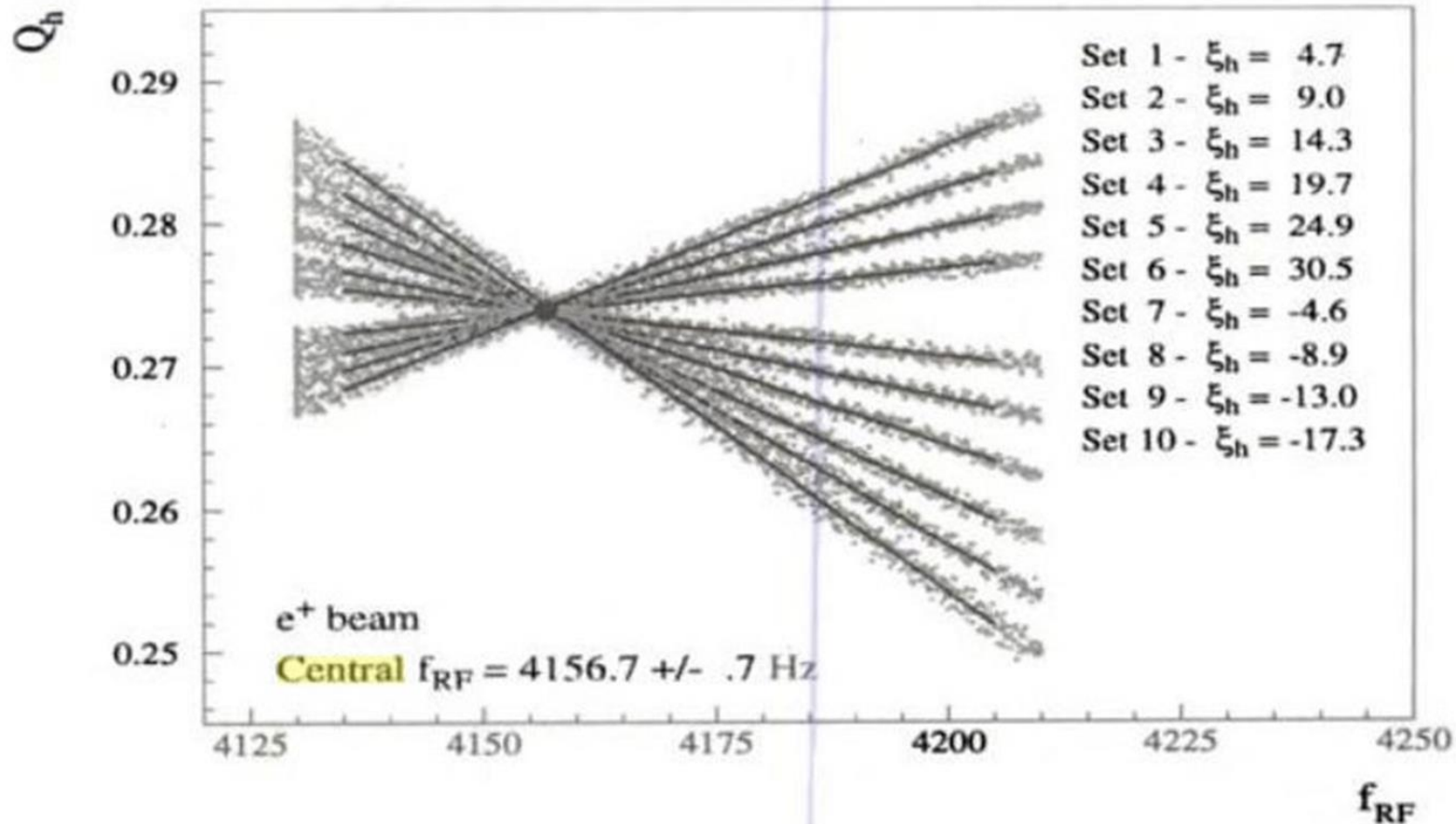
Focal length is  
energy dependent



# Chromaticity Measurements...

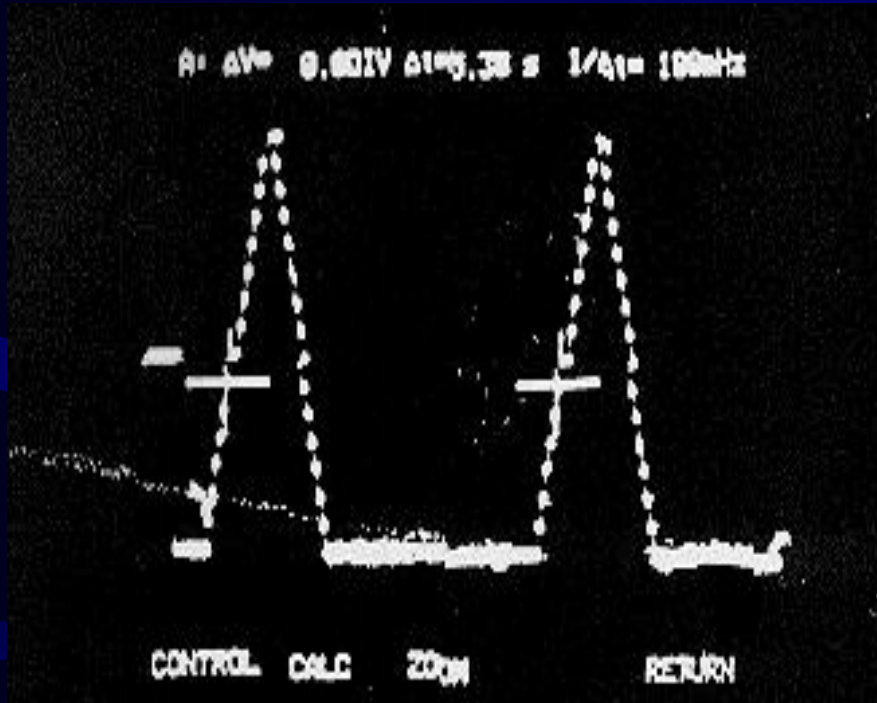
Simply by using the definition:

- Measure betatron tune for different beam momenta;
- vary beam momentum by changing the Rf-frequency

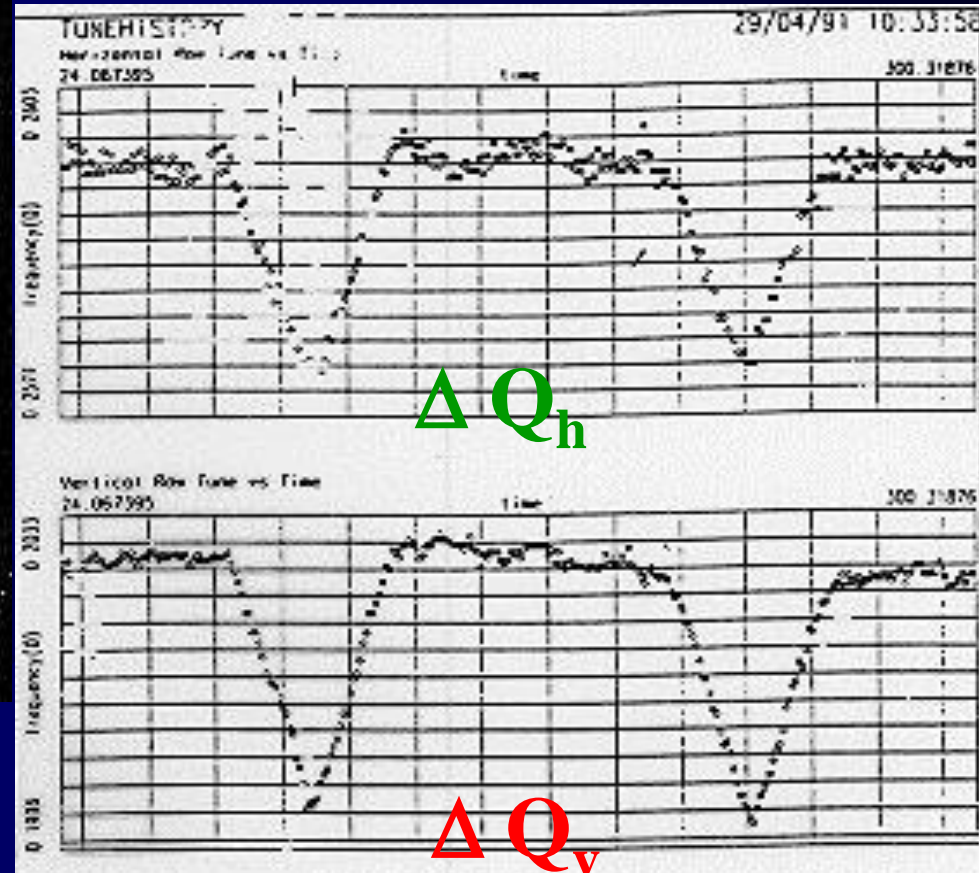




# Time resolved Q' Measurement



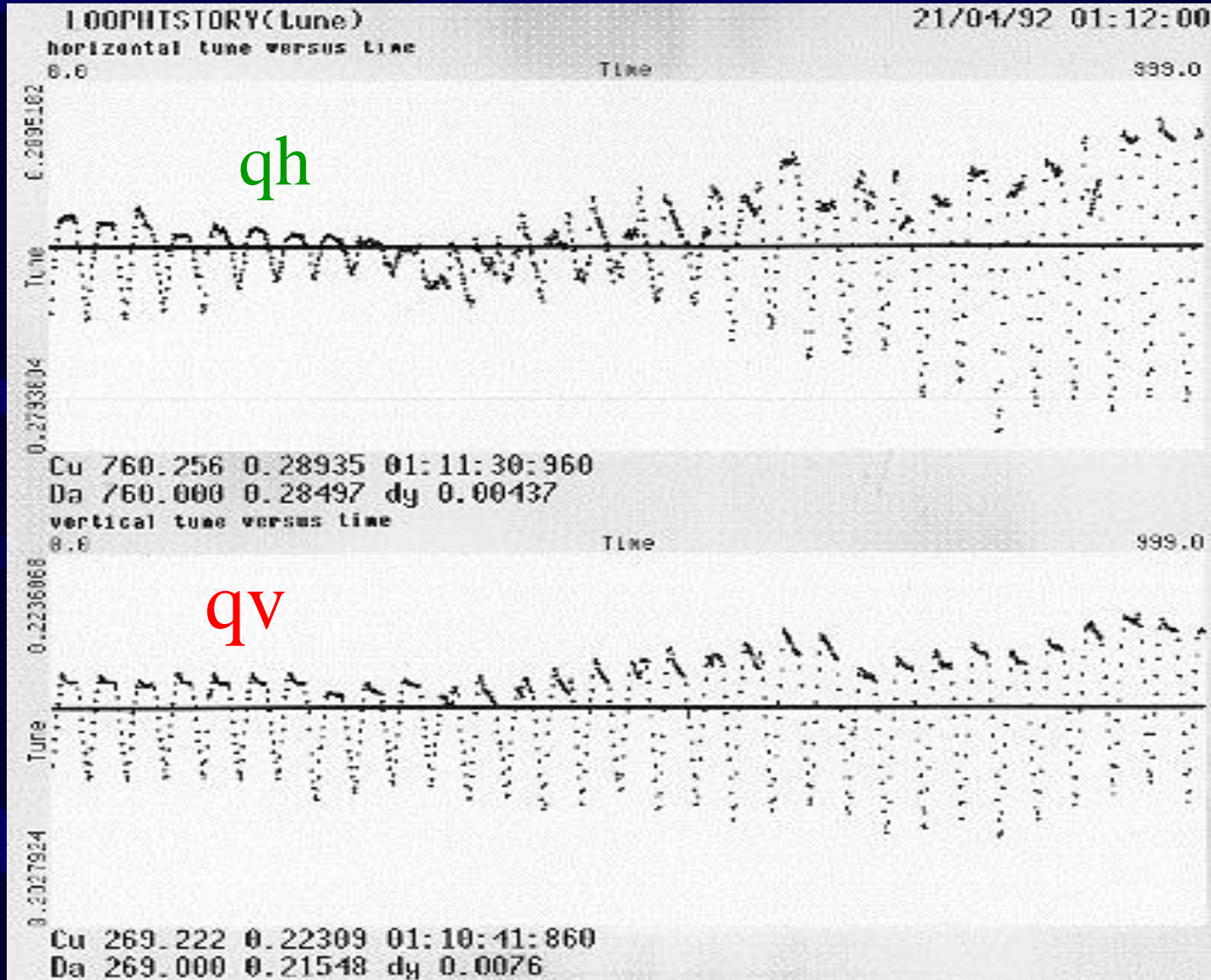
Applied Frequency Shift  
 $\Delta F$  (RF)



Amplitude & sign of chromaticity  
calculated from continuous tune plot



# Measurement Example during LEP $\beta$ -squeeze





# Last not least....

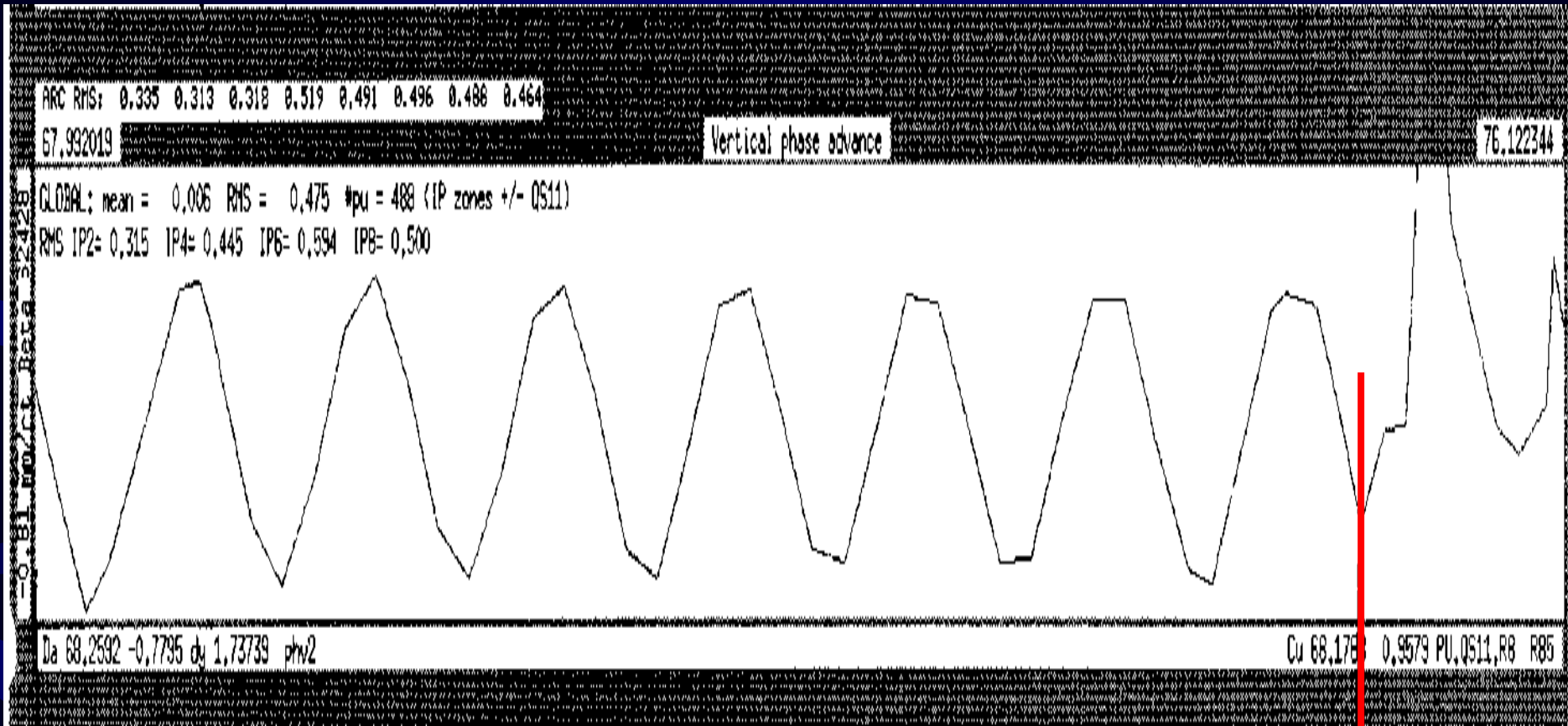
...a story from the good old days:

LEP after a technical stop

- no way to make the beam do one turn around the accelerator
- With BPM readings localize the problem to about 20 meters
- local check of equipment (quadrupole polarity...)
- radiography of beam pipe
- finally: cut beam pipe open



# LEP – No Circulating Beam after at technical stop

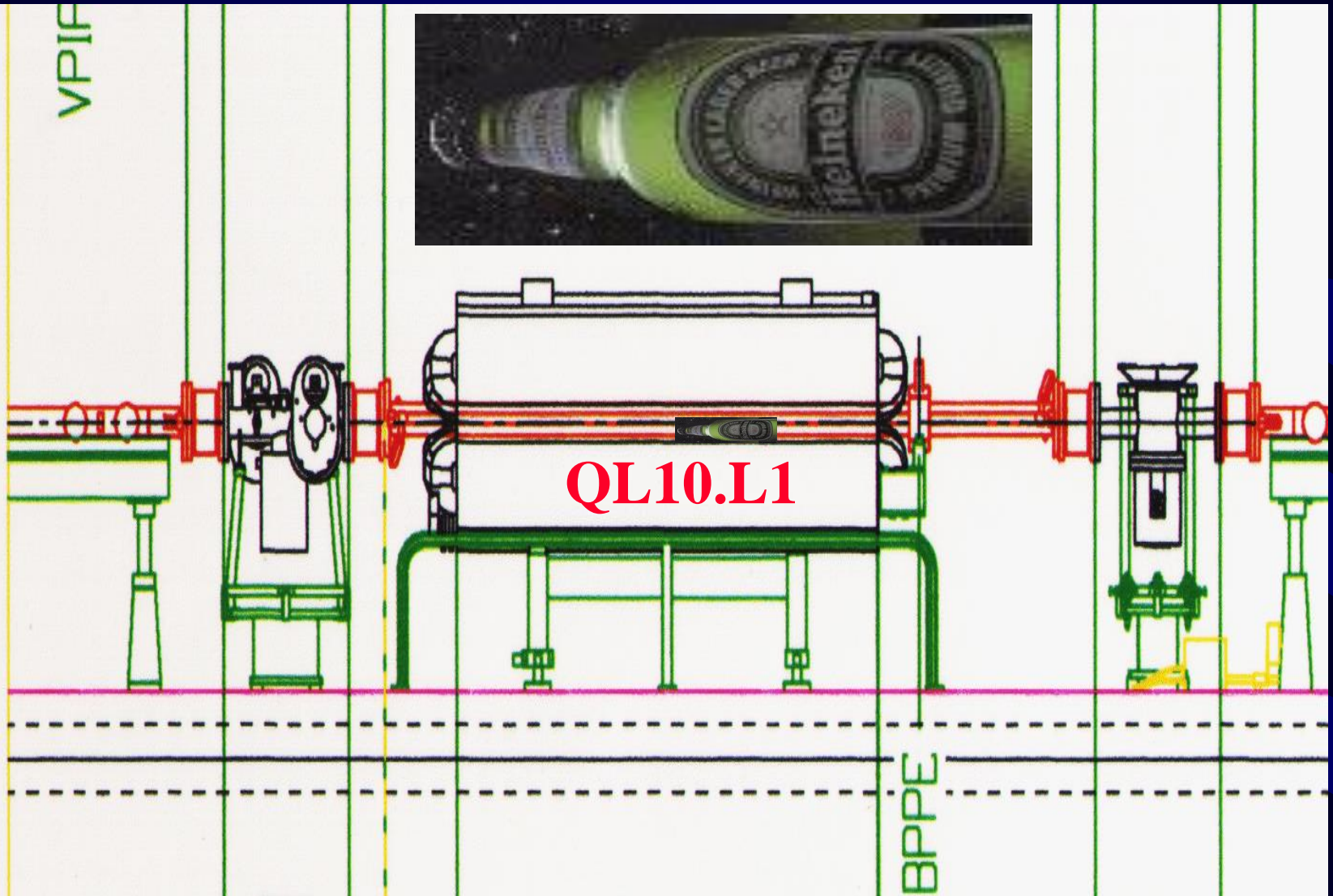


Positrons →

QL10.L1

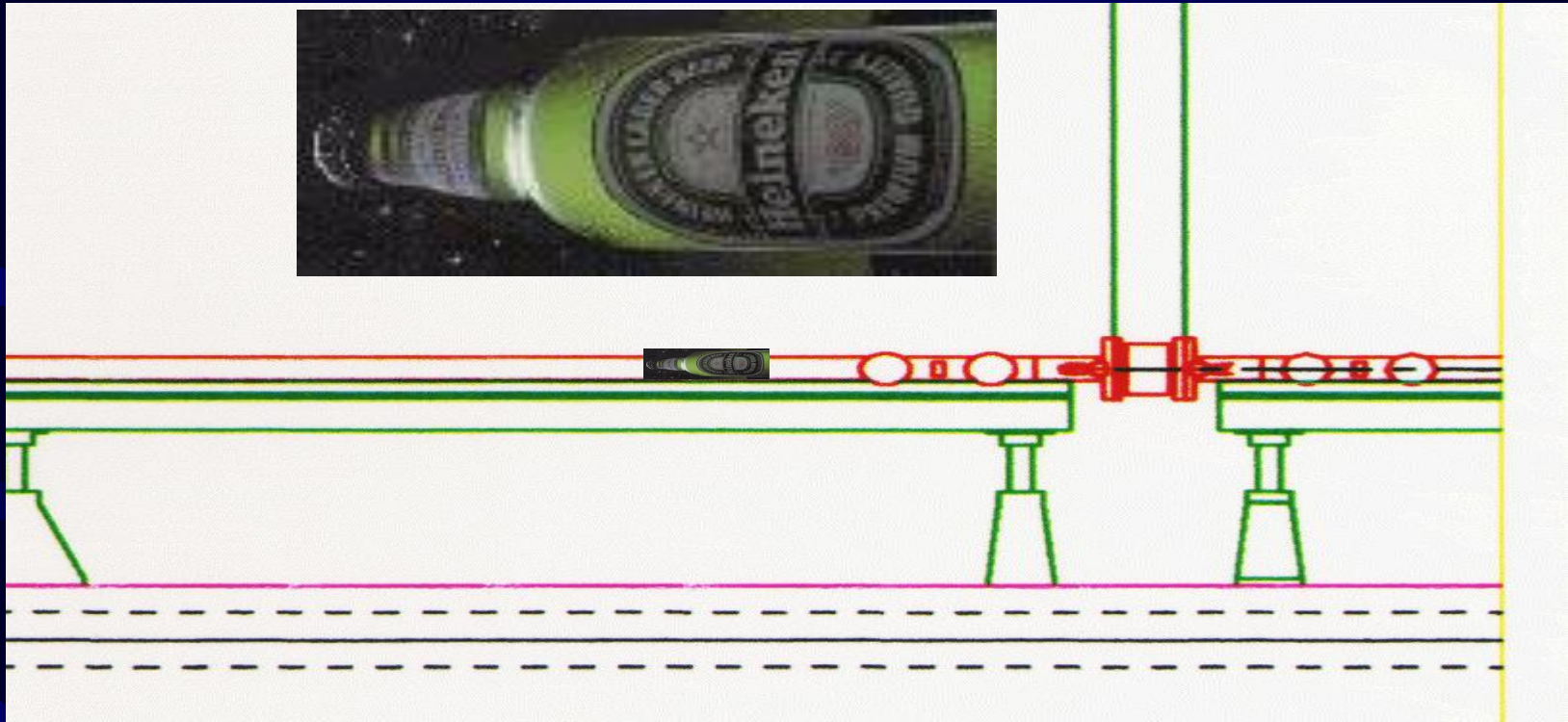


# Zoom on QL1





& 10 metres to the right ...



Unsociable sabotage: **both bottles were empty!!**



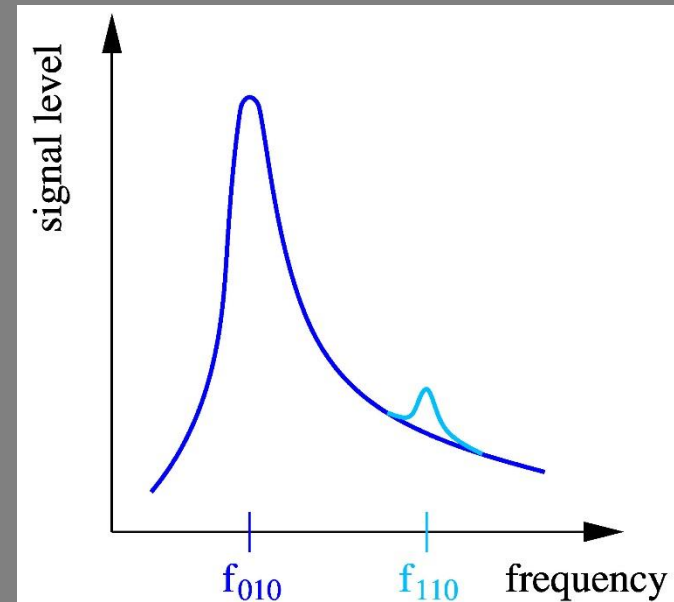
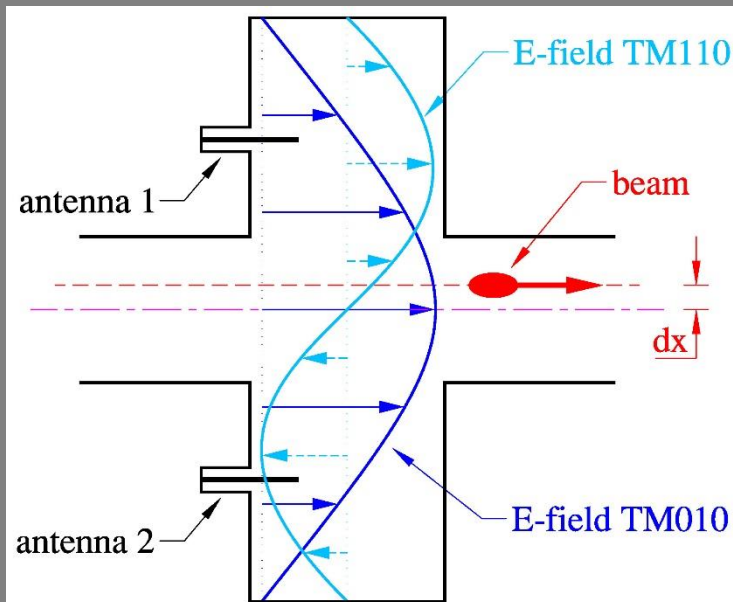


# Reserve slides



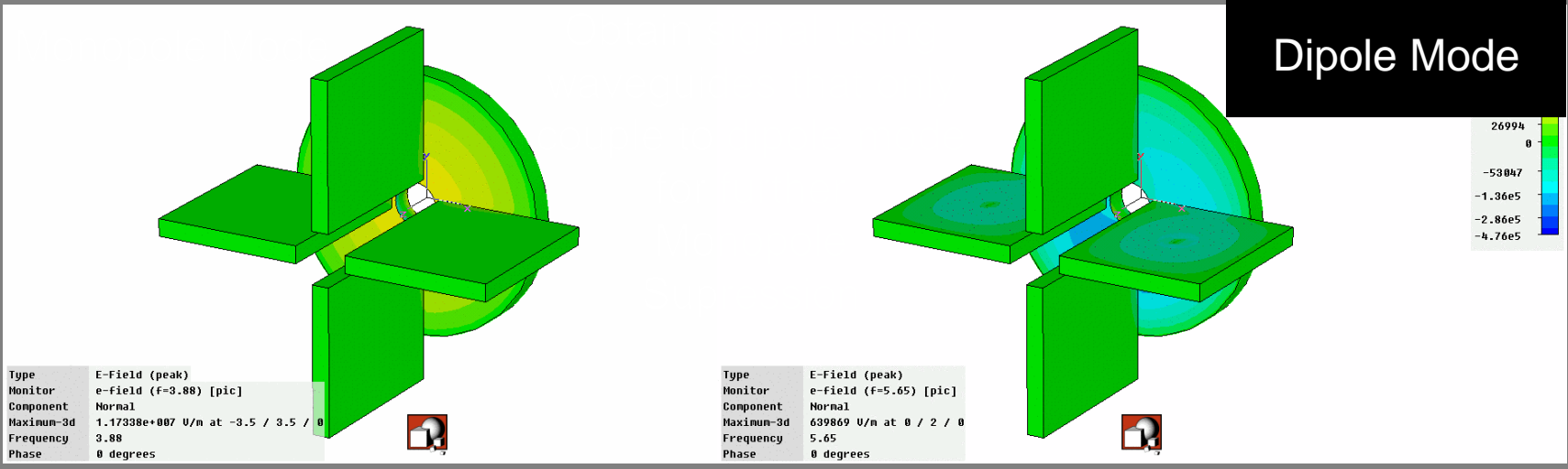
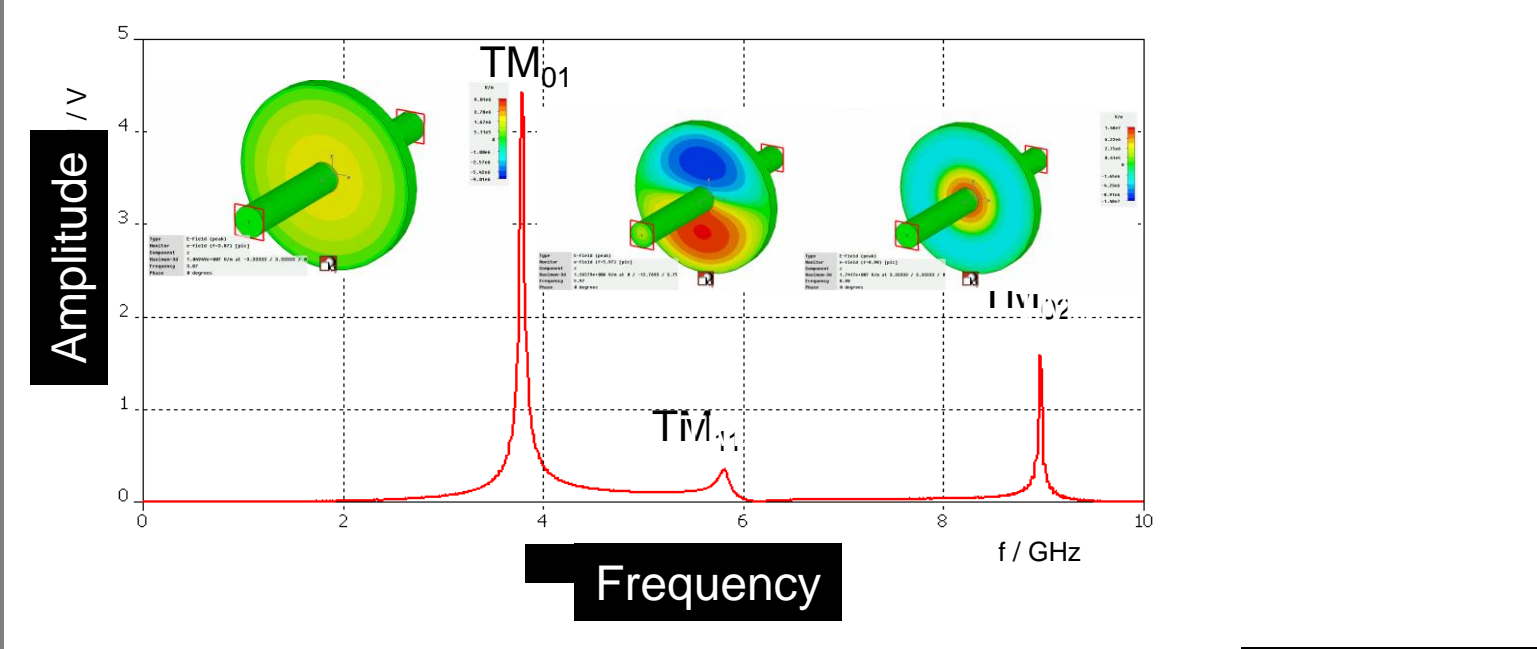
# Improving Precision for Next Generation Accelerators

- BPM electrodes typically give “intensity signals” with some position dependence!
  - Need to remove intensity content to get to the position
  - Difficult to do electronically without some intensity information leaking through
    - When looking for small differences this leakage can dominate the measurement
- Solution – cavity BPM allowing sub micron resolution
  - Design the detector to collect only the difference signal
    - Dipole Mode  $TM_{11}$  proportional to POSITION OFFSET (& intensity)
    - Shifted in frequency with respect to intensity dependent Monopole Mode  $TM_{01}$





# Cavity Beam Position Monitors



Dipole Mode

# Today's State of the Art BPMs

- **Prototype BPM for ILC Final Focus**

- Required resolution of 2nm (yes nano!) in a  $6 \times 12$ mm diameter beam pipe
- Achieved World Record (so far!) resolution of 8.7nm at ATF2 (KEK, Japan)

Courtesy of D. Lipka & Y. Honda

